Description

The 8T49N286 has two independent, fractional-feedback PLLs that can be used as jitter attenuators and frequency translators. It is equipped with six integer and two fractional output dividers, allowing the generation of up to eight different output frequencies, ranging from 8kHz to 1GHz. Four of these frequencies are completely independent of each other and the inputs. The other four are related frequencies. The eight outputs may select among LVPECL, LVDS, HCSL or LVCMOS output levels.

This functionality makes it ideal to be used in any frequency translation application, including 1G, 10G, 40G and 100G Synchronous Ethernet, OTN, and SONET/SDH, including ITU-T G.709 (2009) FEC rates. The device may also behave as a frequency synthesizer.

The 8T49N286 accepts up to four differential or single-ended input clocks and a crystal input. Each of the two internal PLLs can lock to different input clocks which may be of independent frequencies. The other two input clocks are intended for redundant backup of the primary clocks and must be related in frequency to their primary.

The device supports hitless reference switching between input clocks. The device monitors all input clocks for Loss of Signal (LOS), and generates an alarm when an input clock failure is detected. Automatic and manual hitless reference switching options are supported. LOS behavior can be set to support gapped or ungapped clocks.

The 8T49N286 supports holdover for each PLL. The holdover has an initial accuracy of ±50ppB from the point where the loss of all applicable input reference(s) has been detected. It maintains a historical average operating point for each PLL that may be returned to in holdover at a limited phase slope.

The device places no constraints on input to output frequency conversion, supporting all FEC rates, including the new revision of ITU-T Recommendation G.709 (2009), most with 0ppm conversion error.

Each PLL has a register-selectable loop bandwidth from 1.4Hz to 360Hz.

Each output supports individual phase delay settings to allow output-output alignment.

The device supports Output Enable inputs and Lock, Holdover and LOS status outputs.

The device is programmable through an I²C interface. It also supports I²C master capability to allow the register configuration to be read from an external EEPROM. The user may select whether the programming interface uses I²C protocols or SPI protocols, however in SPI mode, read from the external EEPROM is not supported.

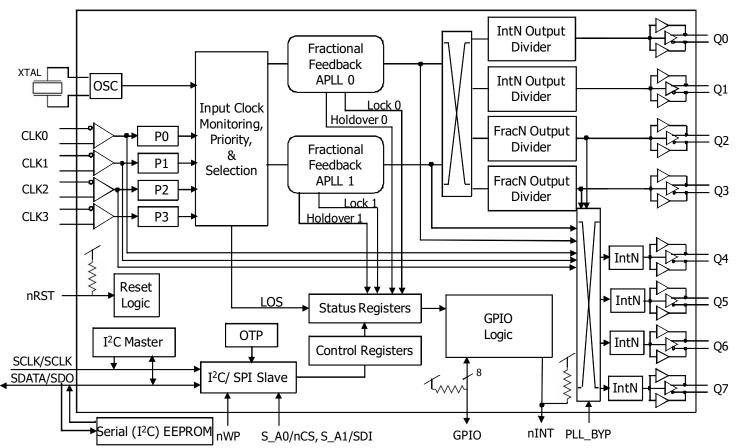
Typical Applications

- OTN or SONET / SDH equipment Line cards (up to OC-192, and supporting FEC ratios)
- OTN de-mapping (Gapped Clock and DCO mode)
- Gigabit and Terabit IP switches / routers including support of ٠ Synchronous Ethernet

- SyncE (G.8262) applications
- · Wireless base station baseband
- Data communications
- 100G Ethernet

Features

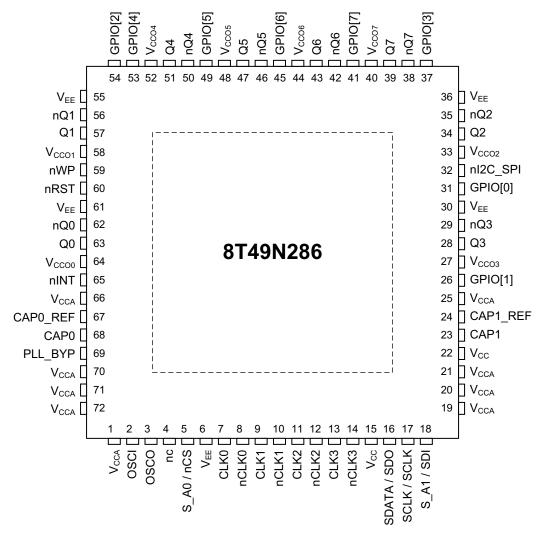
- Supports SDH/SONET and Synchronous Ethernet clocks including all FEC rate conversions
- <0.3ps RMS Typical Jitter (including spurs), 12kHz to 20MHz
- Operating modes: locked to input signal, holdover and free-run
- Initial holdover accuracy of ±50ppb
- Accepts up to four LVPECL, LVDS, LVHSTL, HCSL or LVCMOS input clocks
 - Accepts frequencies ranging from 8kHz up to 875MHz
 - Auto and manual input clock selection with hitless switching
 - Clock input monitoring, including support for gapped clocks
- Phase-Slope Limiting and Fully Hitless Switching options to ٠ control output phase transients
- Operates from a 10MHz to 40MHz fundamental-mode crystal
- Generates 8 LVPECL / LVDS / HCSL or 16 LVCMOS output clocks
 - Output frequencies ranging from 8kHz up to 1.0GHz (diff)
 - Output frequencies ranging from 8kHz to 250MHz (LVCMOS)
- ٠ Eight General Purpose I/O pins with optional support for status and control
 - Eight Output Enable control inputs
 - Lock, Holdover and Loss-of-Signal status outputs
- Open-drain Interrupt pin
- Write-protect pin to prevent configuration registers being altered
- Nine programmable loop bandwidth settings for each PLL from 1.4Hz to 360Hz.
 - Optional Fast Lock function
- Programmable output phase delays in steps as small as 16ps
- Register programmable through I²C / SPI or via external I²C EEPROM
- Bypass clock paths for system tests
- Power supply modes: V_{CC} / V_{CCA} / V_{CCO} 3.3V / 3.3V / 3.3V 3.3V / 3.3V / 2.5V 3.3V / 3.3V / 1.8V (LVCMOS) 2.5V / 2.5V / 3.3V 2.5V / 2.5V / 2.5V 2.5V / 2.5V / 1.8V (LVCMOS)
- -40°C to 85°C ambient operating temperature
- Package: 72QFN, lead-free RoHs (6)



8T49N286 Block Diagram

Figure 1. 8T49N286 Functional Block Diagram

Pin Assignment



72-pin, 10mm x 10mm VFQFN Package

Figure 2. Pinout Drawing

Pin Description and Pin Characteristic Tables

Table 1. Pin Descriptions

Number	Name	Т	уре	Description
2	OSCI	Ι		Crystal Input. Accepts a 10MHz - 40MHz reference from a clock oscillator or a 12pF fundamental mode, parallel-resonant crystal.
3	OSCO	0		Crystal Output. This pin should be connected to a crystal. If an oscillator is connected to OSCI, then this pin must be left unconnected.
5	S_A0 / nCS	I	Pulldown	I ² C lower address bit A0 / SPI interface chip select signal.
16	SDATA / SDO	I/O	Pullup	I ² C interface bi-directional Data / SPI interface serial data output signal.
17	SCLK / SCLK	I/O	Pullup	I ² C interface bi-directional Clock / SPI interface clock input signal.
18	S_A1 / SDI	I	Pulldown	I ² C lower address bit A1 / SPI interface serial data input signal.
32	nl2C_SPI	I	Pulldown	Serial Interface Mode Selection. LVCMOS Input Levels: 0 = I ² C Mode 1 = SPI Mode
7	CLK0	I	Pulldown	Non-inverting differential clock input.
8	nCLK0	Ι	Pullup/ Pulldown	Inverting differential clock input. $V_{CC}/2$ when left floating (set by the internal pullup and pulldown resistors.)
9	CLK1	I	Pulldown	Non-inverting differential clock input.
10	nCLK1	I	Pullup/ Pulldown	Inverting differential clock input. $V_{CC}/2$ when left floating (set by the internal pullup and pulldown resistors.)
11	CLK2	I	Pulldown	Non-inverting differential clock input.
12	nCLK2	Ι	Pullup/ Pulldown	Inverting differential clock input. $V_{CC}/2$ when left floating (set by the internal pullup and pulldown resistors.)
13	CLK3	I	Pulldown	Non-inverting differential clock input.
14	nCLK3	I	Pullup/ Pulldown	Inverting differential clock input. $V_{CC}/2$ when left floating (set by the internal pullup and pulldown resistors.)
63, 62	Q0, nQ0	0	Universal	Output Clock 0. Please refer to Output Drivers for more details.
57, 56	Q1, nQ1	0	Universal	Output Clock 1. Please refer to Output Drivers for more details.
34, 35	Q2, nQ2	0	Universal	Output Clock 2. Please refer to Output Drivers for more details.
28, 29	Q3, nQ3	0	Universal	Output Clock 3. Please refer to Output Drivers for more details.
51, 50	Q4, nQ4	0	Universal	Output Clock 4. Please refer to Output Drivers for more details.
47, 46	Q5, nQ5	0	Universal	Output Clock 5. Please refer to Output Drivers for more details.
43, 42	Q6, nQ6	0	Universal	Output Clock 6. Please refer to Output Drivers for more details.
39, 38	Q7, nQ7	0	Universal	Output Clock 7. Please refer to Output Drivers for more details.
60	nRST	I	Pullup	Master Reset input. LVTTL / LVCMOS interface levels. 0 = All registers and state machines are reset to their default values 1 = Device runs normally
65	nINT	0	Open-drain with pullup	Interrupt output.
59	nWP	I	Pullup	Write protect input. LVTTL / LVCMOS interface levels: 0 = Write operations on the serial port will complete normally, but will have no effect except on interrupt registers 1 = Serial port writes may change any register
41, 45, 49, 53, 37, 54, 26, 31	GPIO[7:0]	I/O	Pullup	General-purpose input-outputs. LVTTL / LVCMOS Input levels Open-drain output. Pulled-up with $5.1 k\Omega$ resistor to $V_{CC.}$
69	PLL_BYP	Ι	Pulldown	Bypass Selection. Allow input references to bypass both PLLs. LVTTL / LVCMOS interface levels.

Number	Name	Туре	Description
6, 30, 36, 55, 61, ePAD	V_{EE}	Power	Negative supply voltage. All $V_{\mbox{\scriptsize EE}}$ pins and EPAD must be connected before any positive supply voltage is applied.
15	V _{CC}	Power	Core and digital function supply voltage.
22	V _{CC}	Power	Core and digital functions supply voltage.
1	V _{CCA}	Power	Analog function supply voltage for core analog functions.
19, 20, 21, 25	V _{CCA}	Power	Analog function supply voltage for analog functions associated with PLL1.
66, 70, 71, 72	V _{CCA}	Power	Analog function supply voltage for analog functions associated with PLL0.
64	V _{CCO0}	Power	High-speed output supply voltage for output pair Q0, nQ0.
58	V _{CCO1}	Power	High-speed output supply voltage for output pair Q1, nQ1.
33	V _{CCO2}	Power	High-speed output supply voltage for output pair Q2, nQ2.
27	V _{CCO3}	Power	High-speed output supply voltage for output pair Q3, nQ3.
52	V _{CCO4}	Power	High-speed output supply voltage for output pair Q4, nQ4.
48	V _{CCO5}	Power	High-speed output supply voltage for output pair Q5, nQ5.
44	V _{CCO6}	Power	High-speed output supply voltage for output pair Q6, nQ6.
40	V _{CCO7}	Power	High-speed output supply voltage for output pair Q7, nQ7.
68, 67	CAP0, CAP0_REF	Analog	PLL0 External Capacitance.
23, 24	CAP1, CAP1_REF	Analog	PLL1 External Capacitance.
4	nc	Unused	No connect.

NOTE: Pullup and Pulldown refer to internal input resistors. See Table 2, Pin Characteristics, for typical values.

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
C _{IN}	Input Capacitance	e; NOTE 1			3.5		pF
R _{PULLUP}	Internal Pullup	nRST, nWP, SDATA / SDO, SCLK / SCLK			51		kΩ
FULLUF	Resistor	nINT			50		kΩ
		GPIO[7:0]			5.1		kΩ
R _{PULLDOWN}	Internal Pulldown	Resistor			51		kΩ
		LVCMOS Q[0:1], Q[4:7]	V _{CCOX} = 3.465V		14.5		pF
		LVCMOS Q[2:3]	V _{CCOX} = 3.465V		18.5		pF
		LVCMOS Q[0:1], Q[4:7]	V _{CCOX} = 2.625V		13		pF
	Power	LVCMOS Q[2:3]	V _{CCOX} = 2.625V		17.5		pF
C _{PD}	Dissipation Capacitance	LVCMOS Q[0:1], Q[4:7]	V _{CCOX} = 1.89V		12.5		pF
	(per output pair)	LVCMOS Q[2:3]	V _{CCOX} = 1.89V		17		pF
		LVDS, HCSL or LVPECL Q[0:1], Q[4:7]	V _{CCOx} = 3.465V or 2.625V		2		pF
		LVDS, HCSL or LVPECL Q[2:3]	V _{CCOx} = 3.465V or 2.625V		4.5		pF
		GPIO[7:0]	Output HIGH		5.1		kΩ
R _{OUT}	Output		Output LOW		25		Ω
	Impedance	LVCMOS Q[7:0], nQ[7:0]			20		Ω

Table 2. Pin Characteristics, $V_{CC} = V_{CCOX} = 3.3V\pm5\%$ or 2.5V±5%

NOTE: V_{CCOX} denotes: V_{CCO0} through $V_{CCO7.}$ NOTE 1: This specification does not apply to OSCI and OSCO pins.

Principles of Operation

The 8T49N286 has two PLLs that can each independently be locked to any of the input clocks and generate a wide range of synchronized output clocks.

It incorporates two completely independent PLLs. These could be used for example in the transmit and receive path of Synchronous Ethernet equipment. Any of the input clocks can be selected as the reference for either PLL. From the output of the two PLLs a wide range of output frequencies can be simultaneously generated.

The 8T49N286 accepts up to four differential input clocks ranging from 8kHz up to 875MHz. It generates up to eight output clocks ranging from 8kHz up to 1.0GHz.

Each PLL path within the 8T49N286 supports three states: Lock, Holdover and Free-run. Lock and holdover status may be monitored on register bits and pins. Each PLL also supports automatic and manual hitless reference switching. In the locked state, the PLL locks to a valid clock input and its output clocks have a frequency accuracy equal to the frequency accuracy of the input clock. In the Holdover state, the PLL will output a clock which is based on the selected holdover behavior. Each of the PLL paths within the 8T49N286 has an initial holdover frequency offset of ±50ppb. In the Free-run state, the PLL outputs a clock with the same frequency accuracy as the external crystal.

Upon power up, each PLL will enter Free-run state, in this state it generates output clocks with the same frequency accuracy as the external crystal. The 8T49N286 continuously monitors each input for activity (signal transitions).

In automatic reference switching, when an input clock has been validated the PLL will transition to the locked state. If the selected input clock fails and there are no other valid input clocks, the PLL will quickly detect that and go into holdover. In the Holdover state, the PLL will output a clock which is based on the selected holdover behavior. If the selected input clock fails and another input clock is available then the 8T49N286 will hitlessly switch to that input clock. The reference switch can be either revertive or non-revertive.

The device supports conversion of any input frequency to four different, independent output frequencies on the Q[0:3] outputs. Additionally, a further four output frequencies may be generated that are integer-related to the four independent frequencies. These additional four frequencies are on the Q[4:7] outputs.

The 8T49N286 has a programmable loop bandwidth from 1.4Hz to 360Hz.

The device monitors all input clocks and generates an alarm when an input clock failure is detected.

The device supports programmable individual output phase adjustments in order to allow control of input to output phase adjustments and output to output phase alignment.

The device is programmable through an I^2C or SPI interface and may also autonomously read its register settings from an internal One-Time Programmable (OTP) memory or an external serial I^2C EEPROM.

Bypass Path

For system test purposes, each of PLL0 and PLL1 may be bypassed. When PLL_BYP is asserted the CLK0 input reference will be presented to the Q4 dividers. The CLK1 input reference will be presented to the Q5 dividers.

Additionally, CLK0, CLK1 or CLK2 may be used as a clock source for the output dividers of Q[4:7]. This may only be done for input frequencies of 250MHz or less.

Input Clock Selection

The 8T49N286 accepts up to four input clocks with frequencies ranging from 8kHz up to 875MHz. Each input can accept LVPECL, LVDS, LVHSTL, HCSL or LVCMOS inputs using 1.8V, 2.5V or 3.3V logic levels. To use LVCMOS inputs, please refer to the Application Note, Wiring the Differential Input to Accept Single-Ended Levels for biasing instructions.

The device has independent input clock selection control for each PLL. In Manual mode, only one of these inputs may be chosen per PLL and if that input fails that PLL will enter holdover.

Manual mode may be operated by directly selecting the desired input reference in the REFSEL register field. It may also operate via pin-selection of the desired input clock by selecting that mode in the REFSEL register field. In that case, GPIOs must be used as Clock Select inputs (CSELn[1:0]) for PLLn.

CSELn[1]	<u>CSELn[0]</u>	Selected Input Reference
0	0	CLK0
0	1	CLK1
1	0	CLK2
1	1	CLK3

In addition, the crystal frequency may be passed directly to the output dividers for Q[4:7] for use as a reference.

Inputs do not support transmission of spread-spectrum clocking sources. Since this family is intended for high-performance applications, it will assume input reference sources to have stabilities of ± 100 ppm or better.

If the PLL is working in automatic mode, then each of the input reference sources is assigned a priority of 1-4. At power-up or if the currently selected input reference fails, the PLL will switch to the highest priority input reference that is valid at that time (see section, Input Clock Monitor for details).

Automatic mode has two sub-options: revertive or non-revertive. In revertive mode, the PLL will switch to a reference with a higher priority setting whenever one becomes valid. In non-revertive mode the PLL remains with the currently selected source as long as it remains valid.

The clock input selection is based on the input clock priority set by the Clock Input Priority control registers. It is recommended that all input references for a PLL be given different priority settings in the Clock Input Priority control registers for that PLL.

Input Clock Monitor

Each clock input is monitored for Loss of Signal (LOS). If no activity has been detected on the clock input within a user-selectable time period then the clock input is considered to be failed and an internal Loss-of-Signal status flag is set, which may cause an input switchover depending on other settings. The user-selectable time period has sufficient range to allow a gapped clock missing many consecutive edges to be considered a valid input.

User-selection of the clock monitor time-period is based on a counter driven by a monitor clock. The monitor clock is fixed at the frequency of PLL0's VCO divided by 8. With a VCO range of 3GHz - 4GHz, the monitor clock has a frequency range of 375MHz to 500MHz.

The monitor logic for each input reference will count the number of monitor clock edges indicated in the appropriate Monitor Control register. If an edge is received on the input reference being monitored, then the count resets and begins again. If the target edge count is reached before an input reference edge is received, then an internal soft alarm is raised and the count re-starts. During the soft alarm period, the PLL(s) tracking this input will not be adjusted. If an input reference edge is received before the count expires for the second time, then the soft alarm status is cleared and the PLL(s) will resume adjustments. If the count expires again without any input reference edge being received, then a Loss-of-Signal alarm is declared.

It is expected that for normal (non-gapped) clock operation, users will set the monitor clock count for each input reference to be slightly longer than the nominal period of that input reference. A margin of 2-3 monitor clock periods should give a reasonably quick reaction time and yet prevent false alarms.

For gapped clock operation, the user will set the monitor clock count to a few monitor clock periods longer than the longest expected clock gap period. The monitor count registers support 17-bit count values, which will support at least a gap length of two clock periods for any supported input reference frequency, with longer gaps being supported for faster input reference frequencies. Since gapped clocks usually occur on input reference frequencies above 100MHz, gap lengths of thousands of periods can be supported.

Using this configuration for a gapped clock, the PLL will continue to adjust while the normally expected gap is present, but will freeze once the expected gap length has been exceeded and alarm after twice the normal gap length has passed.

Once a LOS on any of the input clocks is detected, the appropriate internal LOS alarm will be asserted and it will remain asserted until that input clock returns and will be validated by the receipt of 8 rising clock edges on that input reference. If another error condition on the same input clock is detected during the validation time then the alarm remains asserted and the validation time starts over.

Each LOS flag may also be reflected on one of the GPIO[7:0] outputs. Changes in status of any reference can also generate an interrupt if not masked.

Holdover

8T49N286 supports a small initial holdover frequency offset for each PLL path in non-gapped clock mode. When the input clock monitor is set to support gapped clock operation, this initial holdover frequency offset is indeterminate since the desired behavior with gapped clocks is for the PLL to continue to adjust itself even if clock edges are missing. In gapped clock mode, the PLL will not enter holdover until the input is missing for at least 2 LOS monitor periods.

The holdover performance characteristics of a clock are referred as its accuracy and stability, and are characterized in terms of the fractional frequency offset. The 8T49N286 can only control the initial frequency accuracy. Longer-term accuracy and stability are determined by the accuracy and stability of the external oscillator.

When a PLL loses all valid input references, it will enter the holdover state. In fast average mode, the PLL will initially maintain its most recent frequency offset setting and then transition at a rate dictated by its selected phase-slope limit setting to a frequency offset setting that is based on historical settings. This behavior is intended to compensate for any frequency drift that may have occurred on the input reference before it was detected to be lost.

The historical holdover value will have three options:

- Return to center of tuning range within the V_{CO} band
- Instantaneous mode the holdover frequency will use the DPLL current frequency 100msec before it entered holdover. The accuracy is shown in Table 12, AC Characteristics Table.
- Fast average mode an internal IIR (Infinite Impulse Response) filter is employed to get the frequency offset. The IIR filter gives a 3dB attenuation point corresponding to a nominal period of 20 minutes. The accuracy is shown in Table 12, AC Characteristics Table.

When entering holdover, each PLL will set a separate internal HOLD alarm internally. This alarm may be read from internal status register, appear on the appropriate GPIO pin and/or assert the nINT output.

While a PLL is in holdover, its frequency offset is now relative to the crystal input and so the output clocks derived from that PLL will be tracing their accuracy to the local oscillator or crystal. At some point in time, depending on the stability & accuracy of that source, the clock(s) derived from that PLL will have drifted outside of the limits of the holdover state and the system will be considered to be in a free-run state. Since this borderline is defined outside the PLL and dictated by the accuracy and stability of the external local crystal or oscillator, the 8T49N286 cannot know or influence when that transition occurs. As a result, the 8T49N286 will remain in the holdover state internally.

Input to Output Clock Frequency

The 8T49N286 is designed to accept any frequency within its input range and generate eight different output frequencies that are independent from the input frequencies. The internal architecture of the device ensures that most translations will result in the exact output frequency specified. Where exact frequency translation is not possible, the frequency translation error will be minimized. Please contact Renesas for configuration software or other assistance in determining if a desired configuration will be supported exactly.

Synthesizer Mode Operation

The device may also act as a frequency synthesizer with either or both PLL's generating their operating frequency from just the crystal input. By setting the SYN_MODEn register bit and setting the STATEn[1:0] field to Freerun, no input clock references are required to generate the desired output frequencies.

Loop Filter and Bandwidth

When operating in Synthesizer Mode as described above, the 8T49N286 has a fixed loop bandwidth of approximately 200kHz. When operating in all other modes, the following information applies:

The 8T49N286 uses no external components to support a range of loop bandwidths:1.40625Hz, 2.8125Hz, 5.625Hz, 11.25Hz, 22.5Hz, 45Hz, 90Hz, 180Hz or 360Hz. Each PLL shall support separate loop filter settings.

The device supports two different loop bandwidth settings for each PLL: acquisition and locked. These loop bandwidths are selected from the list of options described above. If enabled, the acquisition bandwidth is used while lock is being acquired to allow the PLL to `fast-lock'. Once locked the PLL will use the locked bandwidth setting. If the acquisition bandwidth setting is not used, the PLL will use the locked bandwidth setting at all times.

Output Dividers and Mapping to PLLs

Each integer output divider block consists of two divider stages in a series to achieve the desired total output divider ratio. The first stage divider may be set to divide by 4, 5 or 6. The second stage of the divider may be bypassed (i.e. divide-by-1) or programmed to any even divider ratio from 2 to 131,070. The total divide ratios, settings and possible output frequencies are shown in Table 3.

In addition, the first divider stage for the Q[4:7] outputs supports a bypass (i.e. divide-by-1) operation for some clock sources.

1st-Stage Divide	2nd-Stage Divide	Total Divide	Minimum F _{OUT} MHz	Maximum F _{OUT} MHz
4	1	4	750	1000
5	1	5	600	800
6	1	6	500	666.7
4	2	8	375	500
5	2	10	300	400
6	2	12	250	333.3
4	4	16	187.5	250
5	4	20	150	200
6	4	24	125	166.7
4	131,070	524,280	0.0057	0.0076
5	131,070	655,350	0.0046	0.0061
6	131,070	786,420	0.0038	0.0051

Table 3, Q[0:1], Q[4:7] Output Divide Ratios

NOTE: Above frequency ranges for Q[4:7] apply when driven directly from PLL0 or PLL1.

Fractional Output Divider Programming (Q2, Q3 only)

For the FracN output dividers Q[2:3], the output divide ratio is given by:

Output Divide Ratio = (N.F)x2

N = Integer Part: 4, 5, ...(2¹⁸-1)

F = Fractional Part: $[0, 1, 2, ...(2^{28}-1)]/(2^{28})$

For integer operation of these outputs dividers, N = 3 is also supported.

Output Divider Frequency Sources

Output dividers associated with the Q[0:3] outputs can take their input frequencies from either PLL0 or PLL1.

Output dividers associated with the Q[4:7] outputs can take their input frequencies from PLL0, PLL1, Q2 or Q3 output dividers, the CLK0, CLK1 or CLK2 input reference frequencies or the crystal frequency.

Output Banks

Outputs of the 8T49N286 are divided into three banks for purposes of output skew measurement.

- Q0, nQ0, Q1, nQ1
- Q4, nQ4, Q5, nQ5
- Q6, nQ6, Q7, nQ7

Output Phase Control on Switchover

There are two options on how the output phase can be controlled when the 8T49N286 enters or leaves the holdover state, or either PLL switches between input references. Phase-slope limiting or fully hitless switching (sometimes called phase build-out) may be selected. The SWMODEn bit selects which behavior is to be followed for PLLn.

If fully hitless switching is selected, then the output phase will remain unchanged under any of these conditions. Note that fully hitless switching is not supported when external loopback is being used. Fully hitless switching should not be used unless all input references are in the same clock domain. Note that use of this mode may prevent an output frequency and phase from being able to trace its alignment back to a primary reference source.

If phase-slope limiting is selected, then the output phase will adjust from its previous value until it is tracking the new condition at a rate dictated by the SLEWn[1:0] bits. Phase-slope limiting should be used if all input references are not in the same clock domain or users wish to retain traceability to a primary reference source.

Input-Output Delay Control

When using the 8T49N286 in external loopback or in a situation where input-output delay needs to be known and controlled, it is necessary to examine the exact signal path through the device. Due to the flexibility of the device, there are a large number of potential signal paths from input to output through it that depend on the desired configuration. Each of those potential paths may include or exclude logic blocks from the path and change the absolute value of the delay (Static Phase Offset or SPO) through the device. Considering the range of SPO values to cover all those potential paths would not be useful in achieving the target delays for any specific user configuration. Please contact Renesas for the specific SPO value associated with a desired input-output path. Note that events such as switch-overs, entering or leaving holdover or re-configuring the signal path can result in one-time changes to the SPO due to that path re-configuration. The AC Characteristics table (Table 12) indicates the maximum variation in SPO that could be expected for a particular path through the device.

Output Phase Alignment

The device has a programmable output to output phase alignment for each of the eight output dividers. After power-up and the PLLs have achieved lock, the device will be in a state where the outputs are synchronized with a deterministic offset relative to each other. After synchronization, the output alignment will depend on the particular configuration of each output according to the following rules. The step size is defined as the period of the clock to that divider:

1) Only outputs derived from the same source will be aligned with each other. 'Source' means the reference selected to drive the output divider as controlled by the CLK_SELn bit for each output.

2) For integer dividers (Q[0:1], Q[4:7]) when both divider stages are active, edges are aligned. This case is used as a baseline to compare the other cases here.

3) For integer dividers where the 1st-stage divider is bypassed (only Q[4:7] support this), coarse delay adjustments can't be performed.

The output phase will be one step earlier than in Case 2.

4) Fractional output dividers (Q2 or Q3) do not guarantee any specific phase on power-up or after a synchronization event.

5) Integer dividers using Q2 or Q3 as a source (Q[4:7] support this option) will be aligned to their source divider's output (Q2 or Q3).

6) Phase alignments listed above may differ by the output-output skews in Table 12, AC Characteristics Table.

Once the device is in operation, the outputs associated with each PLL may have their phase adjustments re-synced in one of two ways:

1) If the PLL becomes unlocked, the coarse phase adjustments will be reset and the fine phase adjustments will be re-loaded once it becomes locked again.

2) Toggling of PLLn_SYN bit may also be used to force a re-sync / re-load for outputs associated with that PLL.

The user may apply adjustments that are proportional to the period of the clock source driving each output divider. For example, if the divider associated with output Q3 is running off PLL0, which has a VCO frequency of 4GHz, then the appropriate period would be 250ps. The output phase may be adjusted in these steps across the full period of the output.

- Coarse Adjustment: all Output Dividers may have their phase adjusted in steps of the source clock period. For example a 4GHz VCO gives a step size of 250ps. The user may request an adjustment of phase of up to 31 steps using a single register write. The phase will be adjusted by lengthening the period of the output by 250ps at a time. This process will be repeated every 4 output clock periods until the full requested adjustment has been achieved. A busy signal will remain asserted in the phase delay register until the requested adjustment is complete. Then a further adjustment may be setup and triggered by toggling the trigger bit.
- Fine Adjustment: For the Fractional Output Dividers associated with the Q2 and Q3 outputs, the phase of those outputs may be further adjusted with a granularity of 1/16th of the VCO period. For example a 4GHz VCO frequency gives a granularity of 16ps. This is performed by directly writing the required offset (from the nominal rising edge position) in units of 1/16th of the output period into a register. Then the appropriate PLLn_SYN bit must be toggled to load the new value. Note that toggling this bit will clear all Coarse Delays for all outputs associated with that PLL, so Fine Delays should be set first, before Coarse Delays. The output will then jump directly to that new offset value. For this reason, this adjustment should be made as the input is initially programmed or in high-impedance.

Each output has the capability of being inverted (180 degree phase shift).

Jitter and Wander Tolerance

The 8T49N286 can be used as a line card device and therefore is expected to tolerate the jitter and wander output of a timing card PLL (e.g. 82P33714).

Output Drivers

The Q0 to Q7 clock outputs are provided with register-controlled output drivers. By selecting the output drive type in the appropriate register, any of these outputs can support LVCMOS, LVPECL, HCSL or LVDS logic levels.

The operating voltage ranges of each output is determined by its independent output power pin (V_{CCO}) and thus each can have different output voltage levels. Output voltage levels of 2.5V or 3.3V are supported for differential operation and LVCMOS operation. In addition, LVCMOS output operation supports 1.8V V_{CCO}.

Each output may be enabled or disabled by register bits and/or GPIO pins configured as Output Enables. The outputs will be enabled if the register bit and the associated OE pin are both asserted (high). When disabled an output will be in a high impedance state.

LVCMOS Operation

When a given output is configured to provide LVCMOS levels, then both the Q and nQ outputs will toggle at the selected output frequency. All the previously described configuration and control apply equally to both outputs. Frequency, phase alignment, voltage levels and enable / disable status apply to both the Q and nQ pins. When configured as LVCMOS, the Q and nQ outputs can be selected to be phase-aligned with each other or inverted relative to one another. Phase-aligned outputs will have increased simultaneous switching currents which can negatively affect phase noise performance and power consumption. It is recommended that use of this selection be kept to a minimum.

Power-Saving Modes

To allow the device to consume the least power possible for a given application, the following functions are included under register control:

- PLL1 may be shut down.
- Any unused output, including all output divider and phase adjustment logic, can be individually powered-off.
- Clock gating on logic that is not being used.

Status / Control Signals and Interrupts

General-Purpose I/Os and Interrupts

The 8T49N286 provides eight General Purpose Input / Output (GPIO) pins for miscellaneous status & control functions. Each GPIO may be configured as an input or an output. Each GPIO may be directly controlled from register bits or be used as a predefined function as shown in Table 4. Note that the default state prior to configuration being loaded from internal OTP or external EEPROM will be to set each GPIO to function as an Output Enable.

	Cor	figured as In	nut	Configured	as Output
		unction	iput	oomgaree	us output
GPIO Pin	Output Enable (default)	Clock Select	General Purpose	Fixed Function	General Purpose
7	OE[7]	CSEL1[1]	GPI[7]	LOS[3]	GPO[7]
6	OE[6]	CSEL0[1]	GPI[6]	LOS[2]	GPO[6]
5	OE[5]	-	GPI[5]	LOS[1]	GPO[5]
4	OE[4]	-	GPI[4]	HOLD[1]	GPO[4]
3	OE[3]	CSEL1[0]	GPI[3]	LOL[1]	GPO[3]
2	OE[2]	CSEL0[0]	GPI[2]	LOS[0]	GPO[2]
1	OE[1]	-	GPI[1]	HOLD[0]	GPO[1]
0	OE[0]	-	GPI[0]	LOL[0]	GPO[0]

If used in the Fixed Function mode of operation, the GPIO bits will reflect the real-time status of their respective status bits as shown in Table 4. Note that the LOL signal represents the lock status of the PLL. It does not account for the process of synchronization of the output dividers associated with that PLL. The output dividers programmed to operate from that PLL will automatically go through a re-synchronization process when the PLL locks or re-locks or if the user triggers a re-sync manually via register bit PLLn_SYN. This synchronization process may result in a period of instability on the affected outputs for a duration of up to 350ns after the re-lock (LOL de-asserts) or the PLLn_SYN bit is de-asserted.

Interrupt Functionality

Table 4. GPIO Configuration

Interrupt functionality includes an interrupt status flag for each of PLL Loss-of-Lock Status (LOL[1:0]), PLL Holdover Status (HOLD[1:0]) and Input Reference Status (LOS[3:0]) that is set whenever there is an alarm on any of those signals. The Status Flag will remain set until the alarm has been cleared and a '1' has been written to the Status Flag's register location or if a reset occurs. Each Status Flag will also have an Interrupt Enable bit that will determine if that Status Flag is allowed to cause the Interrupt Status to be affected (enabled) or not (disabled). All Interrupt Enable bits will be in the disabled state after reset. The Device Interrupt Status flag and nINT output pin are asserted if any of the enabled Interrupt Status flags are set.

Device Hardware Configuration

The 8T49N286 supports an internal One-Time Programmable (OTP) memory that can be pre-programmed at the factory with one complete device configuration. If the device is set to read a configuration from an external, serial EEPROM, then the values read will overwrite the OTP-defined values.

This configuration can be over-written using the serial interface once reset is complete. Any configuration written via the programming interface needs to be re-written after any power cycle or reset. Please contact Renesas if a specific factory-programmed configuration is desired.

Device Start-up and Reset Behavior

The 8T49N286 has an internal power-up reset (POR) circuit and a Master Reset input pin nRST. If either is asserted, the device will be in the Reset State.

For highly programmable devices, it is common practice to reset the device immediately after the initial power-on sequence. Renesas recommends connecting the nRST input pin to a programmable logic source for optimal functionality. It is recommended that a minimum pulse width of 10ns be used to drive the nRST input pin.

While in the reset state (nRST input asserted or POR active), the device will operate as follows:

- All registers will return to & be held in their default states as indicated in the applicable register description.
- All internal state machines will be in their reset conditions.
- The serial interface will not respond to read or write cycles.
- The GPIO signals will be configured as OE[7:0] inputs.
- · All clock outputs will be disabled.
- All interrupt status and Interrupt Enable bits will be cleared, negating the nINT signal.

Upon the latter of the internal POR circuit expiring or the nRST input negating, the device will exit reset and begin self-configuration.

The device will load an initial block of its internal registers using the configuration stored in the internal One-Time Programmable (OTP) memory. Once this step is complete, the 8T49N286 will check the register settings to see if it should load the remainder of its configuration from an external I²C EEPROM at a defined address or continue loading from OTP. See the section on I2C Boot-up

Initialization Mode for details on how this is performed.

Once the full configuration has been loaded, the device will respond to accesses on the serial port and will attempt to lock both PLLs to the selected sources and begin operation. Once the PLLs are locked, all the outputs derived from a given PLL will be synchronized and output phase adjustments can then be applied if desired.

Serial Control Port Description

Serial Control Port Configuration Description

The device has a serial control port capable of responding as a slave in an I^2C or SPI compatible configuration, to allow access to any of the internal registers for device programming or examination of internal status. All registers are configured to have default values. See the specifics for each register for details. Selection of I^2C versus SPI protocol will be done via an input pin.

The device has the additional capability of becoming a master on the I^2C bus only for the purpose of reading its initial register configurations from a serial EEPROM on the I^2C bus. Writing of the configuration to the serial EEPROM must be performed by another device on the same I^2C bus or pre-programmed into the device prior to assembly. This capability is unavailable if SPI protocols are selected for the programming interface.

SPI Mode Operation

In a read operation (R/W bit is '1') data on SDO will be clocked out on the falling edge of SCLK.

In a write operation (R/\overline{W} bit is '0'), data on SDI will be clocked in on the rising edge of SCLK.

Read (LSB first)

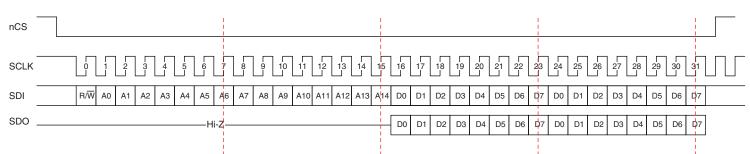


Figure 3. SPI Read Sequencing Diagram

During SPI Write operations, the user may continue to hold nCS low and provide further bytes of data for up to a total of 32,767 bytes in a single block write. Once nCS is driven high, then all data will be written into sequential registers starting at the address given.

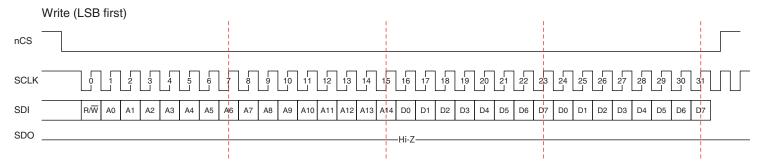


Figure 4. SPI Write Sequencing Diagram

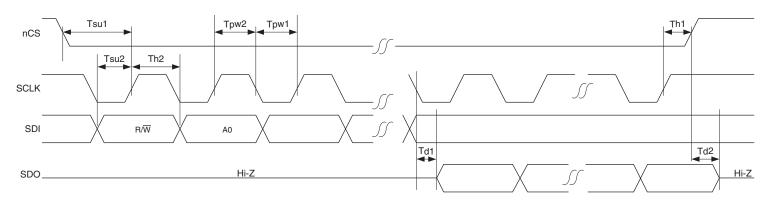


Figure 5. SPI Read/Write Timing Diagram

Table 5. Timing Characteristics in SPI Mode

Symbol	Parameter	Min	Тур	Max	Unit
Т	Internal timing parameter used to calculate SPI timing specs	Т	= PLL0 period *	64	ns
t _{su1}	Valid nCS to SCLK rising setup time	2T			ns
t _{su2}	Valid SDI to SCLK rising setup time	5			ns
t _{d1}	SCLK falling to valid data delay time			4T + 5	ns
t _{d2}	nCS rising edge to SDO high impedance delay time			15	ns
t _{pw1}	SCLK pulse width low	5T			ns
t _{pw2}	SCLK pulse width high	5T			ns
t _{h1}	Valid nCS after valid SCLK hold time	2T			ns
t _{h2}	Valid SDI after valid SCLK hold time	3T			ns
t _{csh}	Time between consecutive Read-Read or Read-Write accesses (nCS rising edge to nCS falling edge)	3Т			ns

NOTE: Specifications guaranteed by design and characterization.

I²C Mode Operation

The I²C interface is designed to fully support v2.1 of the I²C Specification for Normal and Fast mode operation. The device acts as a slave device on the I²C bus at 100kHz or 400kHz using the address defined in the Serial Interface Control register (0006h), as modified by the S_A0 & S_A1 input pin settings. The interface accepts byte-oriented block write and block read operations. Two address bytes specify the register address of the byte position of the first register to write or read. Data bytes (registers) are accessed in sequential order from the lowest to the highest byte (most significant bit first). Read and write block transfers can be stopped after any complete byte transfer. During a write operation, data will not be moved into the registers until the STOP bit is received, at which point, all data received in the block write will be written simultaneously.

For full electrical I²C compliance, it is recommended to use external pull-up resistors for SDATA and SCLK. The internal pull-up resistors have a size of $51k\Omega$ typical.

Current Read

S Dev Add	dr+R A	Data 0	А	Data 1	А	•••	Α	Data n	Ā	Ρ

Sequential Read

S	Dev Addr + W	A	Offset Addr MSB	А	Offset Addr LSB	Α	Sr	Dev Addr + R	А	Data 0	A	Data 1	A	.	А	Data n	Ā	Р
														L -				

Sequential Write

S	Dev Addr + W	А	Offset Addr MSB	А	Offset Addr LSB	А	Data 0	А	Data 1	А	•••	А	Data n	Α	Ρ
			-												

From master to slave	S = Start
From slave to master	Sr = Repeated start
	A = Acknowledge
	Ā = Non-acknowledge
	P = Stop

Figure 6. I²C Slave Read and Write Cycle Sequencing

I²C Master Mode

When operating in I^2C mode, the 8T49N286 has the capability to become a bus master on the I^2C bus for the purposes of reading its configuration from an external I^2C EEPROM. Only a block read cycle will be supported.

As an I²C bus master, the 8T49N286 will support the following functions:

- 7-bit addressing mode
- Base address register for EEPROM
- Validation of the read block via CCITT-8 CRC check against value stored in last byte (E0h) of EEPROM
- Support for 100kHz and 400kHz operation with speed negotiation. If bit d0 is set at Byte address 05h in the EEPROM, this will shift from 100kHz operation to 400kHz operation.
- Support for 1- or 2-byte addressing mode
- · Master arbitration with programmable number of retries

- Fixed-period cycle response timer to prevent permanently hanging the l^2C bus.
- Read will abort with an alarm (BOOTFAIL) if any of the following conditions occur: Slave NACK, Arbitration Fail, Collision during Address Phase, CRC failure, Slave Response time-out

The 8T49N286 will not support the following functions:

- I²C General Call
- Slave clock stretching
- I²C Start Byte protocol
- EEPROM Chaining
- · CBUS compatibility
- Responding to its own slave address when acting as a master
- Writing to external I²C devices including the external EEPROM used for booting

Sequential Read (1-Byte Offset Address)

S	Dev Addr + W	А	Offset Addr	A	Sr	Dev Addr + R	A	Data 0	Α	Data 1	Α	•••	Α	Data n	Ā	Р
												L _				

Sequential Read (2-Byte Offset Address)

S		А	Offset Addr MSB	А	Offset Addr LSB	А	Sr	Dev Addr + R	А	Data 0	А	Data 1	А	_ •••	А	Data n	Ā	Ρ
---	--	---	-----------------	---	-----------------	---	----	--------------	---	--------	---	--------	---	--------------	---	--------	---	---

From master to slave S = Start

From slave to master

A = Acknowledge

 $\overline{A} = Non-acknowledge$

Sr = Repeated start

P = Stop

Figure 7. I²C Master Read Cycle Sequencing

I²C Boot-up Initialization Mode

If enabled (via the BOOT_EEP bit in the Startup register), once the nRST input has been de-asserted (high) and its internal power-up reset sequence has completed, the device will contend for ownership of the l^2 C bus to read its initial register settings from a memory location on the l^2 C bus. The address of that memory location is kept in non-volatile memory in the Startup register. During the boot-up process, the device will not respond to serial control port accesses. Once the initialization process is complete, the contents of any of the device's registers can be altered. It is the responsibility of the user to make any desired adjustments in initial values directly in the serial bus memory.

If a NACK is received to any of the read cycles performed by the device during the initialization process, or if the CRC does not match the one stored in address E0h of the EEPROM the process will be aborted and any uninitialized registers will remain with their default values. The BOOTFAIL bit (021Eh) in the Global Interrupt Status register will also be set in this event.

If the BOOTFAIL bit is set, then both LOL[n] indicators will be set.

Contents of the EEPROM should be as shown in Table 6.

EEPROM Offset				C	ontents			
(Hex)	D7	D6	D5	D4	D3	D2	D1	D0
00	1	1	1	1	1	1	1	1
01	1	1	1	1	1	1	1	1
02	1	1	1	1	1	1	1	1
03	1	1	1	1	1	1	1	1
04	1	1	1	1	1	1	1	1
05	1	1	1	1	1	1	1	Serial EEPROM Speed Select 0 = 100kHz 1 = 400kHz
06	1		8T49N286	Device I ² C Ac	dress [6:2]		1	1
07	0	0	0	0	0	0	0	0
08 - DF			Desire	d contents of E	Device Register	s 08h - DFh		
E0				Serial E	EPROM CRC			
E1 - FF				ι	Inused			

Table 6. External Serial EEPROM Contents

Register Descriptions

Table 7A. Register Blocks

Register Ranges Offset (Hex)	Register Block Description
0000 - 0001	Startup Control Registers
0002 - 0005	Device ID Control Registers
0006 - 0007	Serial Interface Control Registers
0008 - 003A	Digital PLL0 Control Registers
003B - 006D	Digital PLL1 Control Registers
006E - 0076	GPIO Control Registers
0077 - 00AB	Output Clock Control Registers
00AC - 00AF	Analog PLL0 Control Registers
00B0 - 00B3	Analog PLL1 Control Registers
00B4 - 00B8	Power-Down Control Registers
00B9 - 00C6	Input Monitor Control Registers
00C7	Interrupt Enable Register
00C8 - 00CB	Digital Phase Detector Control Registers
00CC - 01FF	Reserved ¹
0200 - 0203	Interrupt Status Registers
0204	Output Phase Adjustment Status Register
0205 - 020E	Digital PLL0 Status Registers
020F - 0218	Digital PLL1 Status Registers
0219	General-Purpose Input Status Register
021A - 021F	Global Interrupt and Boot Status Register
0220 - 03FF	Reserved ¹

NOTE 1: Reserved. Always write 0 to this bit location. Read values are not defined.

Table 7B. Startup Control Register Bit Field Locations and Descriptions

	Startup Control Register Block Field Locations											
Address (Hex)	D7	D6	D5	D3	D2	D1	D0					
0000			EEP_RTY[4:0]			Rsvd	nBOOT_OTP	nBOOT_EEP				
0001	EEP_A15				0]	·						

		Startup Co	ntrol Register Block Field Descriptions
Bit Field Name	Field Type	Default Value	Description
EEP_RTY[4:0]	R/W	00001b	Select number of times arbitration for the I ² C bus to read the serial EEPROM will be retried before being aborted. Note that this number does not include the original try.
nBOOT_OTP	R/W	NOTE 1	Internal One-Time Programmable (OTP) memory usage on power-up: 0 = Load power-up configuration from OTP 1 = Only load 1st eight bytes from OTP
nBOOT_EEP	R/W	NOTE 1	External EEPROM usage on power-up: 0 = Load power-up configuration from external serial EEPROM (overwrites OTP values) 1 = Don't use external EEPROM
EEP_A15	R/W	NOTE 1	Serial EEPROM supports 15-bit addressing mode (multiple pages).
EEP_ADDR[6:0]	R/W	NOTE 1	I ² C base address for serial EEPROM.
Rsvd	R/W	-	Reserved. Always write 0 to this bit location. Read values are not defined.

NOTE 1: These values are specific to the device configuration and can be customized when ordering. Please refer to the FemtoClock NG Universal Frequency Translator Ordering Product Information guide for more details.

Table 7C. Device ID Control Register Bit Field Locations and Descriptions

	Device ID Register Control Block Field Locations												
Address (Hex)	D7	D7 D6 D5 D4 D3 D2 D1											
0002		REV_ID[3:0] DEV_ID[15:12]											
0003				DEV_I	D[11:4]								
0004		DEV_ID[3:0] DASH_CODE[10:7]											
0005		DASH_CODE[6:0]											

		Device ID 0	Control Register Block Field Descriptions
Bit Field Name	Field Type	Default Value	Description
REV_ID[3:0]	R/W	0000b	Device revision.
DEV_ID[15:0]	R/W	0604h	Device ID code.
DASH_CODE [10:0]	R/W	NOTE 1	Device Dash Code: Decimal value assigned by Renesas to identify the configuration loaded at the factory. May be over-written by users at any time. Refer to <i>FemtoClock NG Universal</i> <i>Frequency Translator Ordering Product Information</i> to identify major configuration parameters associated with this Dash Code value.

NOTE 1: These values are specific to the device configuration and can be customized when ordering. Please refer to the FemtoClock NG Universal Frequency Translator Ordering Product Information guide or custom datasheet addendum for more details.

Table 7D. Serial Interface Control Register Bit Field Locations and Descriptions

		Serial Ir	nterface Co	ontrol Block F	ield Location	s						
Address (Hex)	D7	D6	D5	95 D4 D3 D2 D1								
0006	SPI_SEL			UFTADD[6:2]			UFTADD[1]	UFTADD[0]				
0007			Rsvd 1									
		Device ID (Control Re	gister Block F	ield Descript	ions						
Bit Field Name	Bit Field Name Field Type Default Value Description											
SPI_SEL	R/O	Ob	Select Mode for serial interface as read from the nI2C_SPI pin: 0 = I ² C 1 = SPI									
UFTADD[6:2]	R/W	NOTE 1	Configura	ble portion of	l ² C Base Addr	ess (bits 6:2) fo	or this device.					
UFTADD[1]	R/O	0b		Address bit 1. See Table 1, F			tatus of the S_A1	/ SDI external				
UFTADD[0]	R/O	Ob	I ² C Base Address bit 0. This address bit reflects the status of the S_A0 / nCS external input pin. See Table 1, Pin Descriptions.									
Rsvd	R/W	-	Reserved	. Always write	0 to this bit loo	ation. Read va	alues are not defi	ned.				

NOTE 1: These values are specific to the device configuration and can be customized when ordering. Generic dash codes -900 through -908, -998 and-999 are available and programmed with the default I²C address of 1111100b. Please refer to the FemtoClock NG Universal Frequency Translator Ordering Product Information guide for more details.

		Digital P	LL0 Input Con	trol Register Bl	ock Field Loo	cations	Digital PLL0 Input Control Register Block Field Locations												
Address (Hex)	D7	D6	D5	D4	D3	D2	D1	D0											
0008		REFSEL0[2:0]			FBSEL0[2:0]	RVRT0	SWMODE0												
0009	PRI0_	_3[1:0]	PRI0	_2[1:0]	PRI0	_1[1:0]	PRIC	0_0[1:0]											
000A	REFDIS0_3	REFDIS0_2	REFDIS0_1	REFDIS0_0	Rsvd	Rsvd	STAT	E0[1:0]											
000B		Rsvd PRE0_0[20:16]																	
000C				PRE0_0)[15:8]														
000D				PRE0_	0[7:0]														
000E		Rsvd				PRE0_1[20:16]													
000F				PRE0_1	I[15:8]														
0010				PRE0_	1[7:0]														
0011		Rsvd				PRE0_2[20:16]													
0012				PRE0_2	2[15:8]														
0013				PRE0_	2[7:0]														
0014		Rsvd PRE0_3[20:16]																	
0015		PRE0_3[15:8]																	
0016				PRE0_	3[7:0]														

Table 7E. Digital PLL0 Input Control Register Bit Field Locations and Descriptions

		Digital PLL0 In	put Control Register Block Field Descriptions
Bit Field Name	Field Type	Default Value	Description
REFSEL0[2:0]	R/W	000ь	Input reference selection for Digital PLL0: 000 = Automatic selection 001 = Manual selection by GPIO inputs 010 through 011 = Reserved 100 = Force selection of Input Reference 0 101 = Force selection of Input Reference 1 110 = Force selection of Input Reference 2 111 = Force selection of Input Reference 3
FBSEL0[2:0]	R/W	000Ь	Feedback mode selection for Digital PLL0: 000 - 011 = internal feedback divider 100 = external feedback from Input Reference 0 101 = external feedback from Input Reference 1 110 = external feedback from Input Reference 2 111 = external feedback from Input Reference 3
RVRT0	R/W	1b	Automatic switching mode for Digital PLL0: 0 = non-revertive switching 1 = revertive switching
SWMODE0	R/W	1b	Controls how Digital PLL0 adjusts output phase when switching between input references: 0 = Absorb any phase differences between old and new input references at the PLL output. Recommended for use when both input references are in the same clock domain. 1 = Limit the maximum rate of phase change at the PLL output when adjusting to a new input reference's phase/frequency using phase-slope limiting as set in the SLEWn bits. Recommended for use when the input references are not in the same clock domain.
PRI0_0[1:0]	R/W	00Ь	Switchover priority for Input Reference 0 when used by Digital PLL0: 00 = 1st priority 01 = 2nd priority 10 = 3rd priority 11 = 4th priority

		Digital PLL0 In	put Control Register Block Field Descriptions
Bit Field Name	Field Type	Default Value	Description
PRI0_1[1:0]	R/W	01b	Switchover priority for Input Reference 1 when used by Digital PLL0: 00 = 1st priority 01 = 2nd priority 10 = 3rd priority 11 = 4th priority
PRI0_2[1:0]	R/W	10b	Switchover priority for Input Reference 2 when used by Digital PLL0: 00 = 1st priority 01 = 2nd priority 10 = 3rd priority 11 = 4th priority
PRI0_3[1:0]	R/W	11b	Switchover priority for Input Reference 3 when used by Digital PLL0: 00 = 1st priority 01 = 2nd priority 10 = 3rd priority 11 = 4th priority
REFDIS0_0	R/W	0b	Input Reference 0 Switching Selection Disable for Digital PLL0: 0 = Input Reference 0 is included in the switchover sequence for Digital PLL0 1 = Input Reference 0 is not included in the switchover sequence for Digital PLL0
REFDIS0_1	R/W	0b	Input Reference 1 Switching Selection Disable for Digital PLL0: 0 = Input Reference 1 is included in the switchover sequence for Digital PLL0 1 = Input Reference 1 is not included in the switchover sequence for Digital PLL0
REFDIS0_2	R/W	0b	Input Reference 2 Switching Selection Disable for Digital PLL0: 0 = Input Reference 2 is included in the switchover sequence for Digital PLL0 1 = Input Reference 2 is not included in the switchover sequence for Digital PLL0
REFDIS0_3	R/W	0b	Input Reference 3 Switching Selection Disable for Digital PLL0: 0 = Input Reference 3 is included in the switchover sequence for Digital PLL0 1 = Input Reference 3 is not included in the switchover sequence for Digital PLL0
STATE0[1:0]	R/W	00ь	Digital PLL0 State Machine Control: 00 = Run automatically 01 = Force FREERUN state - set this if in Synthesizer Mode for PLL0. 10 = Force NORMAL state 11 = Force HOLDOVER state
PRE0_0[20:0]	R/W	000000h	Pre-divider ratio for Input Reference 0 when used by Digital PLL0.
PRE0_1[20:0]	R/W	000000h	Pre-divider ratio for Input Reference 1 when used by Digital PLL0.
PRE0_2[20:0]	R/W	000000h	Pre-divider ratio for Input Reference 2 when used by Digital PLL0.
PRE0_3[20:0]	R/W	000000h	Pre-divider ratio for Input Reference 3 when used by Digital PLL0.
Rsvd	R/W	-	Reserved. Always write 0 to this bit location. Read values are not defined.

		Digital P	LL0 Feedback	Control Regis	ter Block Field	Locations							
Address (Hex)	D7	D6	D5	D4	D3	D2	D1	D0					
0017				M1_(0_0[23:16]								
0018				M1_	0_0[15:8]								
0019				M1_	_0_0[7:0]								
001A				M1_0	0_1[23:16]								
001B				M1_	0_1[15:8]								
001C				M1_	_0_1[7:0]								
001D		M1_0_2[23:16]											
001E		M1_0_2[15:8]											
001F		 M1_0_2[7:0]											
0020		M1_0_3[23:16]											
0021		M1_0_3[15:8]											
0022		M1_0_3[7:0]											
0023		LCKBW0[3:0] ACQBW0[3:0]											
0024	L	CKDAMP0[2	:0]		ACQDAMP0[2:	0]	AIN0[1:0]						
0025		Rsvd		Rsvd		Rsvd		Rsvd					
0026				1	Rsvd								
0027					Rsvd								
0028				Rsvd				Rsvd					
0029					Rsvd								
002A					Rsvd								
002B					FFh								
002C					FFh								
002D					FFh								
002E					FFh								
002F	SLEW	/0[1:0]	Rsvd	HOL	D0[1:0]	Rsvd	HOLDAVG0	FASTLCK0					
0030				LO	CK0[7:0]		I						
0031				Rsvd				DSM_INT0[8]					
0032				DSM	_INT0[7:0]								
0033		Rsvd				DSMFRAC0[2	20:16]						
0034				DSMF	RAC0[15:8]								
0035				DSM	RAC0[7:0]								
0036					Rsvd								
0037					01h								
0038					Rsvd								
0039					Rsvd								
003A	DSM_OF	RD0[1:0]	DCXOG	AIN0[1:0]	Rsvd		DITHGAIN0[2	:0]					

Table 7F. Digital PLL0 Feedback Control Register Bit Field Locations and Descriptions

Digital PLL0 Feedback Configuration Register Block Field Descriptions							
Bit Field Name	Field Type	Default Value	Description				
M1_0_0[23:0]	R/W	070000h	M1 Feedback divider ratio for Input Reference 0 when used by Digital PLL0.				
M1_0_1[23:0]	R/W	070000h	M1 Feedback divider ratio for Input Reference 1 when used by Digital PLL0.				
M1_0_2[23:0]	R/W	070000h	M1 Feedback divider ratio for Input Reference 2 when used by Digital PLL0.				
M1_0_3[23:0]	R/W	070000h	M1 Feedback divider ratio for Input Reference 3 when used by Digital PLL0.				
LCKBW0[3:0]	R/W	0111Ь	Digital PLL0 Loop Bandwidth while locked: 0000 = Reserved 0010 = Reserved 0011 = 1.40625Hz 0100 = 2.8125Hz 0101 = 5.625Hz 0110 = 11.25Hz 0111 = 22.5Hz 1000 = 45Hz 1001 = 90Hz 1010 = 180Hz 1011 = 360Hz 1100 through 1111 = Reserved				
ACQBW0[3:0]	R/W	0111b	Title through 1111 = Reserved Digital PLL0 Loop Bandwidth while in acquisition (not-locked): 0000 = Reserved 0011 = Reserved 0010 = Reserved 0011 = 1.40625Hz 0100 = 2.8125Hz 0101 = 5.625Hz 0110 = 11.25Hz 0111 = 22.5Hz 1000 = 45Hz 1001 = 90Hz 1011 = 360Hz 1100 through 1111 = Reserved				
LCKDAMP0[2:0]	R/W	011b	Damping factor for Digital PLL0 while locked: 000 = Reserved 001 = 1 010 = 2 011 = 5 100 = 10 101 = 20 110 = Reserved 111 = Reserved				
ACQDAMP0[2:0]	R/W	011b	Damping factor for Digital PLL0 while in acquisition (not locked): 000 = Reserved 001 = 1 010 = 2 011 = 5 100 = 10 101 = 20 110 = Reserved 111 = Reserved				

Digital PLL0 Feedback Configuration Register Block Field Descriptions							
Bit Field Name	Field Type	Default Value	Description				
PLLGAIN0[1:0]	R/W	01b	Digital Loop Filter Gain Settings for Digital PLL0: 00 = 0.5 01 = 1 10 = 1.5 11 = 2				
SLEW0[1:0]	R/W	00b	Phase-slope control for Digital PLL0: 00 = no limit - controlled by loop bandwidth of Digital PLL0, NOTE1. 01 = 83 µsec/sec 10 = 13 µsec/sec 11 = Reserved				
HOLD0[1:0]	R/W	00b	Holdover Averaging mode selection for Digital PLL0: 00 = Instantaneous mode - uses historical value 100ms prior to entering holdover 01 = Fast Average Mode 10 = Reserved 11 = Set VCO control voltage to V _{CC} /2				
HOLDAVG0	R/W	Ob	Holdover Averaging Enable for Digital PLL0: 0 = Holdover averaging disabled 1 = Holdover averaging enabled as defined in HOLD0[1:0]				
FASTLCK0	R/W	Ob	Enables Fast Lock operation for Digital PLL0: 0 = Normal locking using LCKBW0 & LCKDAMP0 fields in all cases 1 = Fast Lock mode using ACQBW0 & ACQDAMP0 when not phase locked and LCKBW0 & LCKDAMP0 once phase locked				
LOCK0[7:0]	R/W	3Fh	Lock window size for Digital PLL0. Unsigned 2's complement binary number in steps of 2.5ns, giving a total range of 640ns. Do not program to 0.				
DSM_INT0[8:0]	R/W	02Dh	Integer portion of the Delta-Sigma Modulator value. Do not set higher than FFh. This implies that for crystal frequencies lower than 16MHz, the doubler circuit must be enabled.				
DSMFRAC0[20:0]	R/W	000000h	Fractional portion of Delta-Sigma Modulator value. Divide this number by 2 ²¹ to determine the actual fraction.				
DSM_ORD0[1:0]	R/W	11b	Delta-Sigma Modulator Order for Digital PLL0: 00 = Delta-Sigma Modulator disabled 01 = 1st order modulation 10 = 2nd order modulation 11 = 3rd order modulation				
DCXOGAIN0[1:0]	R/W	01b	Multiplier applied to instantaneous frequency error before it is applied to the Digitally Controlled Oscillator in Digital PLL0: 00 = 0.5 01 = 1 10 = 2 11 = 4				
DITHGAIN0[2:0]	R/W	000b	Dither Gain setting for Digital PLL0: 000 = no dither 001 = Least Significant Bit (LSB) only 010 = 2 LSBs 011 = 4 LSBs 100 = 8 LSBs 101 = 16 LSBs 110 = 32 LSBs 111 = 64 LSBs				
Rsvd	R/W	-	Reserved. Always write 0 to this bit location. Read values are not defined.				

NOTE 1: Settings other than "00" may result in a significant increase in initial lock time.

	Digital PLL1 Input Control Register Block Field Locations										
Address (Hex)	D7	D6	D5	D4	D3	D2	D1	D0			
003B		REFSEL1[2:0]	I		FBSEL1[2:0]		RVRT1	SWMODE1			
003C	PRI1_	_3[1:0]	PRI1	_2[1:0]	PRI1	_1[1:0]	PRI1	_0[1:0]			
003D	REFDIS1_3	REFDIS1_2	REFDIS1_1	REFDIS1_0	Rsvd	Rsvd	STAT	E1[1:0]			
003E		Rsvd	I			PRE1_0[20:16]]				
003F				PRE1_0	0[15:8]						
0040				PRE1_	0[7:0]						
0041		Rsvd				PRE1_1[20:16]					
0042				PRE1_	1[15:8]						
0043				PRE1_	1[7:0]						
0044		Rsvd				PRE1_2[20:16]					
0045				PRE1_2	2[15:8]						
0046		PRE1_2[7:0]									
0047	Rsvd PRE1_3[20:16]										
0048		PRE1_3[15:8]									
0049				PRE1_	3[7:0]						

Table 7G. Digital PLL1 Input Control Register Bit Field Locations and Descriptions

	Digital PLL1 Input Control Register Block Field Descriptions								
Bit Field Name	Field Type	Default Value	Description						
REFSEL1[2:0]	R/W	000ь	Input reference selection for Digital PLL1: 000 = Automatic selection 001 = Manual selection by GPIO inputs 010 through 011 = Reserved 100 = Force selection of Input Reference 0 101 = Force selection of Input Reference 1 110 = Force selection of Input Reference 2 111 = Force selection of Input Reference 3						
FBSEL1[2:0]	R/W	000ь	Feedback mode selection for Digital PLL1: 000 through 011 = internal feedback divider 100 = external feedback from Input Reference 0 101 = external feedback from Input Reference 1 110 = external feedback from Input Reference 2 111 = external feedback from Input Reference 3						
RVRT1	R/W	1b	Automatic switching mode for Digital PLL1: 0 = non-revertive switching 1 = revertive switching						
SWMODE1	R/W	1b	Controls how Digital PLL1 adjusts output phase when switching between input references: 0 = Absorb any phase differences between old and new input references at the PLL output. Recommended for use when both input references are in the same clock domain. 1 = Limit the maximum rate of phase change at the PLL output when adjusting to a new input reference's phase/frequency using phase-slope limiting as set in the SLEWn bits. Recommended for use when the input references are not in the same clock domain.						
PRI1_0[1:0]	R/W	00Ь	Switchover priority for Input Reference 0 when used by Digital PLL1: 00 = 1st priority 01 = 2nd priority 10 = 3rd priority 11 = 4th priority						

	Digital PLL1 Input Control Register Block Field Descriptions							
Bit Field Name	Field Type	Default Value	Description					
PRI1_1[1:0]	R/W	01b	Switchover priority for Input Reference 1 when used by Digital PLL1: 00 = 1st priority 01 = 2nd priority 10 = 3rd priority 11 = 4th priority					
PRI1_2[1:0]	R/W	10b	Switchover priority for Input Reference 2 when used by Digital PLL1: 00 = 1st priority 01 = 2nd priority 10 = 3rd priority 11 = 4th priority					
PRI1_3[1:0]	R/W	11b	Switchover priority for Input Reference 3 when used by Digital PLL1: 00 = 1st priority 01 = 2nd priority 10 = 3rd priority 11 = 4th priority					
REFDIS1_0	R/W	Ob	Input Reference 0 Switching Selection Disable for Digital PLL1: 0 = Input Reference 0 is included in the switchover sequence for Digital PLL1 1 = Input Reference 0 is not included in the switchover sequence for Digital PLL1					
REFDIS1_1	R/W	Ob	Input Reference 1 Switching Selection Disable for Digital PLL1: 0 = Input Reference 1 is included in the switchover sequence for Digital PLL1 1 = Input Reference 1 is not included in the switchover sequence for Digital PLL1					
REFDIS1_2	R/W	Ob	Input Reference 2 Switching Selection Disable for Digital PLL1: 0 = Input Reference 2 is included in the switchover sequence for Digital PLL1 1 = Input Reference 2 is not included in the switchover sequence for Digital PLL1					
REFDIS1_3	R/W	Ob	Input Reference 3 Switching Selection Disable for Digital PLL1: 0 = Input Reference 3 is included in the switchover sequence for Digital PLL1 1 = Input Reference 3 is not included in the switchover sequence for Digital PLL1					
STATE1[1:0]	R/W	00Ь	Digital PLL1 State Machine Control: 00 = Run automatically 01 = Force FREERUN state - set this if in Synthesizer Mode for PLL1 10 = Force NORMAL state 11 = Force HOLDOVER state					
PRE1_0[20:0]	R/W	000000h	Pre-divider ratio for Input Reference 0 when used by Digital PLL1.					
PRE1_1[20:0]	R/W	000000h	Pre-divider ratio for Input Reference 1 when used by Digital PLL1.					
PRE1_2[20:0]	R/W	000000h	Pre-divider ratio for Input Reference 2 when used by Digital PLL1.					
PRE1_3[20:0]	R/W	000000h	Pre-divider ratio for Input Reference 3 when used by Digital PLL1.					
Rsvd	R/W	-	Reserved. Always write 0 to this bit location. Read values are not defined.					

		Digital PL	L1 Feedback	Control Regis	ter Block Fiel	d Locations					
Address (Hex)	D7	D6	D5	D4	D3	D2	D1	D0			
004A		M1_1_0[23:16]									
004B		M1_1_0[15:8]									
004C		M1_1_0[7:0]									
004D		M1_1_1[23:16]									
004E				M1	_1_1[15:8]						
004F				M	_1_1[7:0]						
0050				M1_	1_2[23:16]						
0051				M1	_1_2[15:8]						
0052				M	_1_2[7:0]						
0053				M1_	1_3[23:16]						
0054				M1	_1_3[15:8]						
0055				M	_1_3[7:0]						
0056		LCKE	3W1[3:0]			AC	QBW1[3:0]				
0057	L	CKDAMP1[2	:0]		ACQDAMP1[2:0]	PLLG	PLLGAIN1[1:0]			
0058		Rsvd		Rsvd		Rsvd	<u> </u>	Rsvd			
0059					Rsvd						
005A					Rsvd						
005B				Rsvd				Rsvd			
005C					Rsvd						
005D					Rsvd						
005E					FFh						
005F					FFh						
0060					FFh						
0061					FFh						
0062	SLEW	1[1:0]	Rsvd	HO	HOLDAVG1	FASTLCK1					
0063				LC	DCK1[7:0]	4	I				
0064				Rsvd				DSM_INT1[8			
0065				DSM	1_INT1[7:0]			1			
0066		Rsvd				DSMFRAC1[20:16]				
0067				DSM	FRAC1[15:8]						
0068				DSM	FRAC1[7:0]						
0069					Rsvd						
006A					01h						
006B		Rsvd									
006C	Rsvd										
006D	DSM_ORD1[1:0] DCXOGAIN1[1:0] Rsvd DITHGAIN1[2:0]										
	Dig	gital PLL1 F	edback Conf	iguration Reg	jister Block Fi	ield Descriptio	ons				
Bit Field Name	Field Type	-		cription		•					
M1_1_0[23:0]	R/W	070	000h M1	Feedback divid	er ratio for Inpu	ut Reference 0	when used by Dig	ital PLI 1.			

Table 7H. Digital PLL1 Feedback Control Register Bit Field Locations and Descriptions

R/W

R/W

070000h

070000h

M1_1_1[23:0]

M1_1_2[23:0]

M1 Feedback divider ratio for Input Reference 1 when used by Digital PLL1.

M1 Feedback divider ratio for Input Reference 2 when used by Digital PLL1.

	Digital PLL1 Feedback Configuration Register Block Field Descriptions							
Bit Field Name	Field Type	Default Value	Description					
M1_1_3[23:0]	R/W	070000h	M1 Feedback divider ratio for Input Reference 3 when used by Digital PLL1.					
LCKBW1[3:0]	R/W	0111Ь	Digital PLL1 Loop Bandwidth while locked: 0000 = Reserved 0001 = Reserved 0010 = Reserved 0011 = 1.40625Hz 0100 = 2.8125Hz 0101 = 5.625Hz 0110 = 11.25Hz 0111 = 22.5Hz 1000 = 45Hz 1001 = 90Hz 1010 = 180Hz 1011 = 360Hz 1100 through 1111 = Reserved					
ACQBW1[3:0]	R/W	0111b	Digital PLL1 Loop Bandwidth while in acquisition (not-locked): 0000 = Reserved 0001 = Reserved 0010 = Reserved 0011 = 1.40625Hz 0100 = 2.8125Hz 0101 = 5.625Hz 0110 = 11.25Hz 0111 = 22.5Hz 1000 = 45Hz 1001 = 90Hz 1010 = 180Hz 1011 = 360Hz 1100 through 1111 = Reserved					
LCKDAMP1[2:0]	R/W	011Ь	Damping factor for Digital PLL1 while locked: 000 = Reserved 001 = 1 010 = 2 011 = 5 100 = 10 101 = 20 110 = Reserved 111 = Reserved					
ACQDAMP1[2:0]	R/W	011b	Damping factor for Digital PLL1 while in acquisition (not locked): 000 = Reserved 001 = 1 010 = 2 011 = 5 100 = 10 101 = 20 110 = Reserved 111 = Reserved					
PLLGAIN1[1:0]	R/W	01b	Digital Loop Filter Gain Settings for Digital PLL1: 00 = 0.5 01 = 1.0 10 = 1.5 11 = 2.0					

	Digita	I PLL1 Feedback	Configuration Register Block Field Descriptions
Bit Field Name	Field Type	Default Value	Description
SLEW1[1:0]	R/W	00b	Phase-slope control for Digital PLL1: 00 = no limit - controlled by loop bandwidth of Digital PLL1, NOTE 1. 01 = 83 µsec/sec 10 = 13 µsec/sec 11 = Reserved
HOLD1[1:0]	R/W	00b	Holdover Averaging mode selection for Digital PLL1: 00 = Instantaneous mode - uses historical value 100ms prior to entering holdover 01 = Fast Average Mode 10 = Reserved 11 = Set VCO control voltage to V _{CC} /2
HOLDAVG1	R/W	0b	Holdover Averaging Enable for Digital PLL1: 0 = Holdover averaging disabled 1 = Holdover averaging enabled as defined in HOLD1[1:0]
FASTLCK1	R/W	Ob	Enables Fast Lock operation for Digital PLL1: 0 = Normal locking using LCKBW1 & LCKDAMP1 fields in all cases 1 = Fast Lock mode using ACQBW1 & ACQDAMP1 when not phase locked and LCKBW1 & LCKDAMP1 once phase locked
LOCK1[7:0]	R/W	3Fh	Lock window size for Digital PLL1. Unsigned 2's complement binary number in steps of 2.5ns, giving a total range of 640ns. Do not program to 0.
DSM_INT1[8:0]	R/W	02Dh	Integer portion of the Delta-Sigma Modulator value. Do not set higher than FFh. This implies that for crystal frequencies lower than 16MHz, the doubler circuit must be enabled.
DSMFRAC1[20:0]	R/W	000000h	Fractional portion of Delta-Sigma Modulator value. Divide this number by 2 ²¹ to determine the actual fraction.
DSM_ORD1[1:0]	R/W	11b	Delta-Sigma Modulator Order for Digital PLL1: 00 = Delta-Sigma Modulator disabled 01 = 1st order modulation 10 = 2nd order modulation 11 = 3rd order modulation
DCXOGAIN1[1:0]	R/W	01b	Multiplier applied to instantaneous frequency error before it is applied to the Digitally Controlled Oscillator in Digital PLL1: 00 = 0.5 01 = 1.0 10 = 2.0 11 = 4.0
DITHGAIN1[2:0]	R/W	000b	Dither Gain setting for Digital PLL1: 000 = no dither 001 = Least Significant Bit (LSB) only 010 = 2 LSBs 011 = 4 LSBs 100 = 8 LSBs 101 = 16 LSBs 110 = 32 LSBs 111 = 64 LSBs
Rsvd	R/W	-	Reserved. Always write 0 to this bit location. Read values are not defined.

NOTE 1: Settings other than "00" may result in a significant increase in initial lock time.

Table 7I. GPIO Control Register Bit Field Locations and Descriptions

The values observed on any GPIO pins that are used as general purpose inputs are visible in the GPI[7:0] register that is located at location 0219h near a number of other read-only registers.

	GPIO Control Register Block Field Locations								
Address (Hex)	D7	D6	D5	D4	D3	D2	D1	D0	
006E				GPIO_I	DIR[7:0]				
006F	GPI7SEL[2]	GPI6SEL[2]	GPI5SEL[2]	GPI4SEL[2]	GPI3SEL[2]	GPI2SEL[2]	GPI1SEL[2]	GPI0SEL[2]	
0070	GPI7SEL[1]	GPI6SEL[1]	GPI5SEL[1]						
0071	GPI7SEL[0]	GPI6SEL[0]	GPI5SEL[0]	GPI4SEL[0]	GPI3SEL[0]	GPI2SEL[0]	GPI1SEL[0]	GPI0SEL[0]	
0072	GPO7SEL[2]	GPO6SEL[2]	GPO5SEL[2]	GPO4SEL[2]	GPO3SEL[2]	GPO2SEL[2]	GPO1SEL[2]	GPO0SEL[2]	
0073	GPO7SEL[1]	GPO6SEL[1]	GPO5SEL[1]	GPO4SEL[1]	GPO3SEL[1]	GPO2SEL[1]	GPO1SEL[1]	GPO0SEL[1]	
0074	GPO7SEL[0]	GPO6SEL[0]	GPO5SEL[0]	GPO4SEL[0]	GPO3SEL[0]	GPO2SEL[0]	GPO1SEL[0]	GPO0SEL[0]	
0075				Rs	vd				
0076				GPC	[7:0]				
		GPI	O Control Reg	jister Block Fie	Id Description	S			
Bit Field Name	Field Type	Default Value	Description	·					
GPIO_DIR[7:0]	R/W	00h	Direction con 0 = input mod 1 = output mod		Purpose I/O Pi	ns GPIO[7:0]:			
GPI0SEL[2:0]	R/W	000Ь	000 = Genera 001 = Output 010 = reserve 011 = reserve	Function of GPIO[0] pin when set to input mode by GPIO_DIR[0] register bit: 000 = General Purpose Input (value on GPIO[0] pin directly reflected in GPI[0] register bit) 001 = Output Enable control for output Q0 010 = reserved 011 = reserved 100 through 111 = reserved					
GPI1SEL[2:0]	R/W	000Ь	000 = Genera 001 = Output 010 = reserve	PIO[1] pin when al Purpose Input Enable control ed 111 = reserved	(value on GPIC				
GPI2SEL[2:0]	R/W	000Ь	000 = Genera 001 = Output 010 = reserve 011 = reserve 100 = reserve 101 = CSEL0	Function of GPIO[2] pin when set to input mode by GPIO_DIR[2] register bit: 000 = General Purpose Input (value on GPIO[2] pin directly reflected in GPI[2] register bit) 001 = Output Enable control for output Q2 010 = reserved 011 = reserved 100 = reserved 101 = CSEL0[0]: Manual Clock Select Input 0 for PLL0 110 through 111 = reserved					
GPI3SEL[2:0]	R/W	000Ь	Function of GPIO[3] pin when set to input mode by GPIO_DIR[3] register bit: 000 = General Purpose Input (value on GPIO[3] pin directly reflected in GPI[3] register bit) 001 = Output Enable control for output Q3 010 = reserved 011 = reserved 101 = CSEL1[0]: Manual Clock Select Input 0 for PLL1 100, 110, 111 = reserved						
GPI4SEL[2:0]	R/W	000b	000 = Genera 001 = Output	PIO[4] pin when al Purpose Input Enable control 111 = reserved	(value on GPIC				

GPIO Control Register Block Field Descriptions						
Bit Field Name	Field Type	Default Value	Description			
GPI5SEL[2:0]	R/W	000Ь	Function of GPIO[5] pin when set to input mode by GPIO_DIR[5] register bit: 000 = General Purpose Input (value on GPIO[5] pin directly reflected in GPI[5] register bit 001 = Output Enable control for output Q5 010 through 111 = reserved			
GPI6SEL[2:0]	R/W	000ь	Function of GPIO[6] pin when set to input mode by GPIO_DIR[6] register bit: 000 = General Purpose Input (value on GPIO[6] pin directly reflected in GPI[6] register bit 001 = Output Enable control for output Q6 101 = CSEL0[1]: Manual Clock Select Input 1 for PLL0 010, 011, 100, 110, 111 = reserved			
GPI7SEL[2:0]	R/W	000ь	Function of GPIO[7] pin when set to input mode by GPIO_DIR[7] register bit: 000 = General Purpose Input (value on GPIO[7] pin directly reflected in GPI[7] register bit 001 = Output Enable control for output Q7 101 = CSEL1[1]: Manual Clock Select Input 1 for PLL1 010, 011, 100, 110, 111 = reserved			
GPO0SEL[2:0]	R/W	000b	Function of GPIO[0] pin when set to output mode by GPIO_DIR[0] register bit: 000 = General Purpose Output (value in GPO[0] register bit driven on GPIO[0] pin 001 = Loss-of-Lock Status Flag for Digital PLL0 reflected on GPIO[0] pin 010 = Loss-of-Lock Status Flag for Digital PLL1 reflected on GPIO[0] pin 011 = reserved 100 = reserved 101 = reserved 110 through 111 = reserved			
GPO1SEL[2:0]	R/W	000Ь	Function of GPIO[1] pin when set to output mode by GPIO_DIR[1] register bit: 000 = General Purpose Output (value in GPO[1] register bit driven on GPIO[1] pin 001 = Holdover Status Flag for Digital PLL0 reflected on GPIO[1] pin 010 = Holdover Status Flag for Digital PLL1 reflected on GPIO[1] pin 011 = reserved 100 = reserved 101 = reserved 110 = reserved 111 = reserved			
GPO2SEL[2:0]	R/W	000ь	Function of GPIO[2] pin when set to output mode by GPIO_DIR[2] register bit: 000 = General Purpose Output (value in GPO[2] register bit driven on GPIO[2] pin 001 = Loss-of-Signal Flag for Input Reference 0 reflected on GPIO[2] pin 010 = reserved 011 = reserved 100 = reserved 101 through 111 = reserved			
GPO3SEL[2:0]	R/W	000ь	Function of GPIO[3] pin when set to output mode by GPIO_DIR[3] register bit: 000 = General Purpose Output (value in GPO[3] register bit driven on GPIO[3] pin 001 = Loss-of-Lock Status Flag for Digital PLL1 reflected on GPIO[3] pin 010 = Loss-of-Signal Status Flag for Input Reference 1 reflected on GPIO[3] pin 011 = reserved 100 = reserved 101 through 111 = reserved			
GPO4SEL[2:0]	R/W	000b	Function of GPIO[4] pin when set to output mode by GPIO_DIR[4] register bit: 000 = General Purpose Output (value in GPO[4] register bit driven on GPIO[4] pin 001 = Holdover Status Flag for Digital PLL1 reflected on GPIO[4] pin 010 through 111 = reserved			
GPO5SEL[2:0]	R/W	000b	Function of GPIO[5] pin when set to output mode by GPIO_DIR[5] register bit: 000 = General Purpose Output (value in GPO[5] register bit driven on GPIO[5] pin 001 = Loss-of-Signal Status Flag for Input Reference 1 reflected on GPIO[5] pin 010 through 111 = reserved			

	GPIO Control Register Block Field Descriptions							
Bit Field Name Field Type Default Value Description								
GPO6SEL[2:0]	R/W	000Ь	Function of GPIO[6] pin when set to output mode by GPIO_DIR[6] register bit: 000 = General Purpose Output (value in GPO[6] register bit driven on GPIO[6] pin 001 = Loss-of-Signal Status Flag for Input Reference 2 reflected on GPIO[6] pin 010 through 111 = reserved					
GPO7SEL[2:0]	R/W	000b	Function of GPIO[7] pin when set to output mode by GPIO_DIR[7] register bit: 000 = General Purpose Output (value in GPO[7] register bit driven on GPIO[7] pin 001 = Loss-of-Signal Status Flag for Input Reference 3 reflected on GPIO[7] pin 010 through 111 = reserved					
GPO[7:0]	R/W	00h	Output Values reflect on pin GPIO[7:0] when General-Purpose Output Mode selected.					
Rsvd	R/W	-	Reserved. Always write 0 to this bit location. Read values are not defined.					

Table 7J. Output Driver Control Register Bit Field Locations and Descriptions

	Output Driver Control Register Block Field Locations										
Address (Hex)	D7	D6	D5	D4	D3	D2	D1	D0			
0077		OUTEN[7:0]									
0078		POL_Q[7:0]									
0079		OUTMODE7[2:0]	SE_MODE7		OUTMODE6[2:0]					
007A		OUTMODE5[2:0)]	SE_MODE5		OUTMODE4[2:0]					
007B	OUTMODE3[2:0]			SE_MODE3		OUTMODE2[2:0]					
007C		OUTMODE1[2:0)]	SE_MODE1		OUTMODE0[2:0] SE					

	Output Driver Control Register Block Field Descriptions							
Bit Field Name	Field Name Field Type Default Value Description							
OUTEN[7:0]	R/W	00h	Output Enable control for Clock Outputs Q[7:0], nQ[7:0]: 0 = Qn is in a high-impedance state 1 = Qn is enabled as indicated in appropriate OUTMODEn[2:0] register field					
POL_Q[7:0]	R/W	00h	Polarity of Clock Outputs Q[7:0], nQ[7:0]: 0 = normal polarity 1 = inverted polarity					
OUTMODEm [2:0]	R/W	001b	Output Driver Mode of Operation for Clock Output Pair Qm, nQm: 000 = High-impedance 001 = LVPECL 010 = LVDS 011 = LVCMOS 100 = HCSL 101 - 111 = reserved					
SE_MODEm	R/W	0b	Behavior of Output Pair Qm, nQm when LVCMOS operation is selected (Must be 0 if LVDS, HCSL or LVPECL output style is selected): 0 = Qm and nQm are both the same frequency but inverted in phase 1 = Qm and nQm are both the same frequency and phase					

Output Divider Control Register Block Field Locations											
Address (Hex)	D7	D6	D5	D4	D3	D2	D1	D0			
007D	Rsvd NS1_Q0[1:0]										
007E	NS2_Q0[15:8]										
007F		NS2_Q0[7:0]									
0080		Rsvd NS1_Q1[1:0]									
0081				NS2_Q	1[15:8]		1				
0082				NS2_C	Q1[7:0]						
0083			R	svd			N_Q	2[17:16]			
0084				N_Q2	[15:8]						
0085				N_Q2	2[7:0]						
0086			R	svd			N_Q	3[17:16]			
0087				N_Q3	[15:8]						
0088				N_Q3	3[7:0]						
0089			R	svd			NS1	_Q4[1:0]			
008A				NS2_Q	4[15:8]		I				
008B				NS2_C	Q4[7:0]						
008C		Rsvd NS1_Q5[1:0]									
008D				NS2_Q	5[15:8]						
008E				NS2_C	Q5[7:0]						
008F			R	svd			NS1	_Q6[1:0]			
0090				NS2_Q	6[15:8]						
0091				NS2_C	Q6[7:0]						
0092			R	svd			NS1	_Q7[1:0]			
0093				NS2_Q	7[15:8]						
0094				NS2_C	Q7[7:0]						
0095		Rs	svd			NFRAC_	Q2[27:24]				
0096	NFRAC_Q2[23:16]										
0097		NFRAC_Q2[15:8]									
0098	NFRAC_Q2[7:0]										
0099		Rs	svd			NFRAC_	Q3[27:24]				
009A				NFRAC_0	23[23:16]						
009B				NFRAC_	Q3[15:8]						
009C				NFRAC	Q3[7:0]						

Table 7K. Output Divider Control Register Bit Field Locations and Descriptions

Output Divider Control Register Block Field Descriptions							
Bit Field Name	Field Type	Default Value	Description				
NS1_Qm[1:0] (m = 0,1)	R/W	10b	1st Stage Output Divider Ratio for Output Clock Qm, nQm (m = 0, 1): 00 = /5 01 = /6 10 = /4 11 = Output Qm, nQm not switching				
NS1_Qm[1:0] (m = 4, 5, 6, 7)	R/W	10b	1st Stage Output Divider Ratio for Output Clock Qm, nQm (m = 4, 5, 6, 7): 00 = /5 01 = /6 10 = /4 11 = /1 (Do not use this selection if PLL0 or PLL1 are the source since the 2nd-stage divider has a limit of 1GHz).				
NS2_Qm[15:0]	R/W	0002h	2nd Stage Output Divider Ratio for Output Clock Qm, nQm (m = 0, 1, 4, 5, 6, 7): Actual divider ratio is 2x the value written here. A value of 0 in this register will bypass the second stage of the divider.				
		Integer Portion of Output Divider Ratio for Output Clock Qm, nQm (m = 2, 3): Values of 0, 1 or 2 cannot be written to this register. Actual integer portion is 2x the value written here.					
NFRAC_Qm[27:0]	R/W	0000000h	Fractional Portion of Output Divider Ratio for Output Clock Qm, nQm (m = 2, 3): Actual fractional portion is 2x the value written here. Fraction = (NFRAC_Qm * 2) * 2^{-28}				
Rsvd	R/W	-	Reserved. Always write 0 to this bit location. Read values are not defined.				

Output Clock Phase Adjustment Control Control Register Block Field Locations									
Address (Hex)	D7	D6	D5	D4	D3	D2	D1	D0	
009D				CRSE_	TRG[7:0]				
009E		Rsvd COARSE0[4:0]							
009F		Rsvd		COARSE1[4:0]					
00A0		Rsvd		COARSE2[4:0]					
00A1		Rsvd		COARSE3[4:0]					
00A2		Rsvd		COARSE4[4:0]					
00A3		Rsvd		COARSE5[4:0]					
00A4		Rsvd		COARSE6[4:0]					
00A5		Rsvd		COARSE7[4:0]					
00A6		Rs	vd	FINE2[3:0]					
00A7		Rs	vd			FINE3	[3:0]		

Table 7L. Output Clock Phase Adjustment Control Register Bit Field Locations and Descriptions

	Output Clock Phase Adjustment Control Register Block Field Descriptions							
Bit Field Name	Field Type	Default Value	Description					
CRSE_TRG[7:0]	R/W	00h	Trigger Coarse Phase Adjustment for output Qm, nQm by amount specified in COARSEm[4:0] register upon $0 \rightarrow 1$ transition of this Trigger register bit. Please ensure the PA_BUSYm status bit is 0 before triggering another adjustment cycle on that particular output. Trigger bit must be returned to 0 before another delay cycle can be triggered.					
COARSEm[4:0]	R/W	00000b	Number of periods to be inserted when Trigger happens. Relevant clock period is determined by the clock source selected for output Qm, nQm in its CLK_SELm register field.					
FINEm[3:0]	R/W	0000Ь	Number of 1/16ths of the relevant clock period to add to the phase of output Qm, nQm (m = 2, 3). Relevant clock period is determined by the clock source selected for output Qm, nQm in its CLK_SELm register field. The PLLn_SYN bit for the PLL driving the output divider for the output in question must be toggled to make this value take effect. Note that toggling the PLLn_SYN bit will clear all Coarse delay values and so Fine delay should be set first.					
Rsvd	R/W	-	Always write a 0 to this bit location. Read values are not defined.					

Table 7M. Output Clock Source Control Register Bit Field Locations and De	escriptions
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		Output C	lock Sou	rce Co	ontrol Register	Block Field L	ocations		
Address (Hex)	D7	D6	D	5	D4	D3	D2	D1	D0
00A8	Rs	Rsvd		SYN	PLL0_SYN	CLK_SEL3	CLK_SEL2	CLK_SEL1	CLK_SEL0
00A9	Rsvd CLK_SE			L5[2:0] Rsvd CLK_SEL4[2:0]]	
00AA	Rsvd		CLK_SE	L7[2:0] Rsvd CLK_SEL6[2			CLK_SEL6[2:0	2:0]	
00AB	1	1		1	1	Rs	svd	R	svd
		Output Cl	ock Sourc	ce Cor	ntrol Register I	Block Field De	scriptions		
Bit Field Name	Field Typ	e Defau	It Value	Desc	ription				
PLL1_SYN	R/W		Db	Output Synchronization Control for Outputs Derived from PLL1. Setting this bit from $0\rightarrow 1$ will cause the output divider(s) for the affected of be held in reset. Setting this bit from $1\rightarrow 0$ will release all the output divider(s) for the affected outputs to run from the same point in time with the coarse output phase adjustment reset to 0.					e affected
PLL0_SYN	R/W		Оb	Output Synchronization Control for Outputs Derived fr Setting this bit from 0→1 will cause the output divider(s be held in reset. Setting this bit from 1→0 will release all the output div outputs to run from the same point in time with the cos adjustment reset to 0.		er(s) for the affe divider(s) for th	(s) for the affected outputs to ivider(s) for the affected		
CLK_SEL0	R/W	R/W 0b		Clock Source Selection for output Q0, nQ0: 0 = PLL0 1 = PLL1					
CLK_SEL1	R/W		1b	Clock Source Selection for output Q1, nQ1: 0 = PLL0 1 = PLL1					
CLK_SEL2	R/W		Db	Clock Source Selection for output Q2, nQ2: 0 = PLL0 1 = PLL1					
CLK_SEL3	R/W		1b	Clock 0 = P 1 = P	LL0	tion for output Q3, nQ3:			
CLK_SEL4[2:0]	R/W	0	Clock Source Sele if that input is faste 000 = PLL0 000b 001 = PLL1 010 = Output Q2, 011 = Output Q3, 100 = Input Refere 101 = Input Refere 110 = Input Refere 111 = Crystal Input			nQ2 nQ3 ence 0 (CLK0) ence 1 (CLK1) ence 2 (CLK2)			
CLK_SEL5[2:0]	R/W	0	10b	Clock Source Selection for output Q5, nQ5. Do not select Input Reference if that input is faster than 250MHz. 000 = PLL0 001 = PLL1 010 = Output Q2, nQ2 011 = Output Q3, nQ3 100 = Input Reference 0 (CLK0) 101 = Input Reference 1 (CLK1) 110 = Input Reference 2 (CLK2) 111 = Crystal Input					erence 0, 1 or 2

	0	utput Clock Sour	ce Control Register Block Field Descriptions
Bit Field Name	Field Type	Default Value	Description
CLK_SEL6[2:0]	R/W	110b	Clock Source Selection for output Q6, nQ6. Do not select Input Reference 0, 1 or 2 if that input is faster than 250MHz. 000 = PLL0 001 = PLL1 010 = Output Q2, nQ2 011 = Output Q3, nQ3 100 = Input Reference 0 (CLK0) 101 = Input Reference 1 (CLK1) 110 = Input Reference 2 (CLK2) 111 = Crystal Input
CLK_SEL7[2:0]	R/W	101b	Clock Source Selection for output Q7, nQ7. Do not select Input Reference 0, 1 or 2 if that input is faster than 250MHz. 000 = PLL0 001 = PLL1 010 = Output Q2, nQ2 011 = Output Q3, nQ3 100 = Input Reference 0 (CLK0) 101 = Input Reference 1 (CLK1) 110 = Input Reference 2 (CLK2) 111 = Crystal Input
Rsvd	R/W	-	Reserved. Always write 0 to this bit location. Read values are not defined.

Table 7N. Analog PLL0 Control Register Bit Field Locations and Descriptions

Please contact Renesas through one of the methods listed on the last page of this datasheet for details on how to set these fields for a particular user configuration.

	Analog PLL0 Control Register Block Field Locations										
Address (Hex)	D7	D6	D5	D4	D3	D2	D1	D0			
00AC	CPSET_0[2:0]			RS_	0[1:0]	CP_0[1:0]		WPOST_0			
00AD	Rsvd				SYN_MODE 0	Rsvd	DLCNT_0	DBITM_0			
00AE	R	svd	VCOMAN_0	DBIT1_0[4:0]							
00AF	Rsvd			DBIT2_0[4:0]							

Analog PLL0 Control Register Block Field Descriptions								
Bit Field Name	Field Type	Default Value	Description					
CPSET_0[2:0]	R/W	100b	Charge Pump Current Setting for Analog PLL0: 000 = 110µA 001 = 220µA 010 = 330µA 011 = 440µA 100 = 550µA 101 = 660µA 110 = 770µA 111 = 880µA					
RS_0[1:0]	R/W	01b	Internal Loop Filter Series Resistor Setting for Analog PLL0: $00 = 330\Omega$ $01 = 640\Omega$ $10 = 1.2k\Omega$ $11 = 1.79k\Omega$					
CP_0[1:0]	R/W	01b	Internal Loop Filter Parallel Capacitor Setting for Analog PLL0: 00 = 40pF 01 = 80pF 10 = 140pF 11 = 200pF					
WPOST_0	R/W	1b	Internal Loop Filter 2nd Pole Setting for Analog PLL0: 0 = Rpost = 497Ω, Cpost = 40pF 1 = Rpost = 1.58kΩ, Cpost = 40pF					
DLCNT_0	R/W	1b	Digital Lock Count Setting for Analog PLL0. Set to 0 if external capacitor (CAP0) for PLL0 is >95nF, otherwise set to 1: 0 = 1 ppm accuracy 1 = 16 ppm accuracy					
DBITM_0	R/W	Ob	Digital Lock Manual Override Setting for Analog PLL0: 0 = Automatic Mode 1 = Manual Mode					
VCOMAN_0	R/W	1b	Manual Lock Mode VCO Selection Setting for Analog PLL0: 0 = VCO2 1 = VCO1					
DBIT1_0[4:0]	R/W	01011b	Manual Mode Digital Lock Control Setting for VCO1 in Analog PLL0.					
DBIT2_0[4:0]	R/W	00000b	Manual Mode Digital Lock Control Setting for VCO2 in Analog PLL0.					
SYN_MODE0	R/W	Ob	Frequency Synthesizer Mode Control for PLL0: 0 = PLL0 jitter attenuates and translates one or more input references 1 = PLL0 synthesizes output frequencies using only the crystal as a reference Note that the STATE0[1:0] field in the Digital PLL0 Control Register must be set to Force Freerun state.					
Rsvd	R/W	-	Reserved. Always write 0 to this bit location. Read values are not defined.					

Table 7O. Analog PLL1 Control Register Bit Field Locations and Descriptions

Please contact Renesas through one of the methods listed on the last page of this datasheet for details on how to set these fields for a particular user configuration.

	Analog PLL1 Control Register Block Field Locations											
Address (Hex)	D7 D6 D5			D4	D3	D2	D1	D0				
00B0	CPSET_1[2:0]			RS_	1[1:0]	CP_1[1:0]		WPOST_1				
00B1	Rsvd				SYN_MODE 1	Rsvd	DLCNT_1	DBITM_1				
00B2	R	svd	VCOMAN_1	DBIT1_1[4:0]								
00B3		Rsvd	·	DBIT2_1[4:0]								

Analog PLL1 Control Register Block Field Descriptions									
Bit Field Name	Field Type	Default Value	Description						
CPSET_1[2:0]	R/W	100b	Charge Pump Current Setting for Analog PLL1: 000 = 110 µA 001 = 220 µA 010 = 330 µA 011 = 440 µA 100 = 550 µA 101 = 660 µA 110 = 770 µA 111 = 880 µA						
RS_1[1:0]	R/W	01b	Internal Loop Filter Series Resistor Setting for Analog PLL1: $00 = 330 \Omega$ $01 = 640 \Omega$ $10 = 1.2 k\Omega$ $11 = 1.79 k\Omega$						
CP_1[1:0]	R/W	01b	Internal Loop Filter Parallel Capacitor Setting for Analog PLL1: 00 - 40 pF 01 = 80 pF 10 = 140 pF 11 = 200 pF						
WPOST_1	R/W	1b	Internal Loop Filter 2nd Pole Setting for Analog PLL1: $0 = Rpost = 497 \Omega$, Cpost = 40pF $1 = Rpost = 1.58 k\Omega$, Cpost = 40pF						
DLCNT_1	R/W	1b	Digital Lock Count Setting for Analog PLL1: Set to 0 if external capacitor (CAP1) for PLL1 is >95nF, otherwise set to 1: 0 = 1 ppm accuracy 1 = 16 ppm accuracy						
DBITM_1	R/W	0b	Digital Lock Manual Override Setting for Analog PLL1: 0 = Automatic Mode 1 = Manual Mode						
VCOMAN_1	R/W	1b	Manual Lock Mode VCO Selection Setting for Analog PLL1: 0 = VCO2 1 = VCO1						
DBIT1_1[4:0]	R/W	01011b	Manual Mode Digital Lock Control Setting for VCO1 in Analog PLL1.						
DBIT2_1[4:0]	R/W	00000b	Manual Mode Digital Lock Control Setting for VCO2 in Analog PLL1.						
SYN_MODE1	R/W	Ob	Frequency Synthesizer Mode Control for PLL1: 0 = PLL1 jitter attenuates and translates one or more input references. 1 = PLL1 synthesizes output frequencies using only the crystal as a reference. Note that the STATE1[1:0] field in the Digital PLL1 Control Register must be set to Force Freerun state.						
Rsvd	R/W	-	Reserved. Always write 0 to this bit location. Read values are not defined.						

Table 7P. Powe	r Down Conti	rol Register I	Bit Field Loc	ations and D	escriptions						
	Power Down Control Register Block Field Locations										
Address (Hex)	D7	D6	D5	D4	D3	D2	D1	D0			
00B4		Rsvd									
00B5		Rs	svd		CLK3_DIS	CLK2_DIS	CLK1_DIS	CLK0_DIS			
00B6		Rsvd		PLL1_DIS							
00B7	Q7_DIS	Q6_DIS	Q5_DIS	Q4_DIS	Q3_DIS	Q2_DIS	Q1_DIS	Q0_DIS			
00B8	Rsvd				DPLL1_DIS	DPLL0_DIS	CALRST1	CALRST0			
		Bower	Down Contro	Pogistor Blog	k Field Descrip	tions	·	•			

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		Power	Down Control Register Block Field Descriptions
Bit Field Name	Field Type	Default Value	Description
DBL_DIS	R/W	0b	Controls whether Crystal Input Frequency is doubled before being used in PLL0 or PLL1: 0 = 2x Actual Crystal Frequency Used 1 = Actual Crystal Frequency Used
CLKm_DIS	R/W	0b	Disable Control for Input Reference m: 0 = Input Reference m is Enabled 1 = Input Reference m is Disabled
PLL1_DIS	R/W	0b	Disable Control for Analog PLL1: 0 = PLL1 Enabled 1 = Analog PLL1 Disabled
Qm_DIS	R/W	0b	Disable Control for Output Qm, nQm: 0 = Output Qm, nQm functions normally 1 = All logic associated with Output Qm, nQm is Disabled & Driver in High-Impedance state
DPLLm_DIS	R/W	0b	Disable Control for Digital PLLm: 0 = Digital PLLm Enabled 1 = Digital PLLm Disabled
CALRSTm	R/W	0b	Reset Calibration Logic for Analog PLLm: 0 = Calibration Logic for Analog PLLm Enabled 1 = Calibration Logic for Analog PLLm Disabled
Rsvd	R/W	-	Reserved. Always write 0 to this bit location. Read values are not defined.

		Input Moni	tor Contro	ol Register Blo	ck Field Locat	ions		
Address (Hex)	D7	D6	D5	D4	D3	D2	D1	D0
00B9				Rsvd			1	LOS_0[16]
00BA				LOS	_0[15:8]			
00BB				LOS	_0[7:0]			
00BC				Rsvd				LOS_1[16]
00BD				LOS	_1[15:8]			
00BE				LOS	_1[7:0]			
00BF		Rsvd						
00C0				LOS	_2[15:8]			
00C1				LOS	_2[7:0]			
00C2				Rsvd				LOS_3[16]
00C3				LOS	_3[15:8]			
00C4				LOS	_3[7:0]			
00C5				R	lsvd			
00C6		Rsvd						
		Input Monito	or Control	Register Bloc	k Field Descrij	otions		
Bit Field Name	Field Type	Default Value	9		D	escription		

Table 7Q. Input Monitor Control Register Bit Field Locations and Descriptions

	Input Monitor Control Register Block Field Descriptions									
Bit Field Name	Bit Field Name Field Type Default Value Description									
LOS_m[16:0]	R/W	1FFFFh	Number of Input Monitoring clock periods before Input Reference m is considered to be missed (soft alarm). Minimum setting is 3.							
Rsvd	R/W	-	Reserved. Always write 0 to this bit location. Read values are not defined.							

Table 7R. Interrupt Enable Control Register Bit Field Locations and Descriptions

	Interrupt Enable Control Register Block Field Locations											
Address (Hex)	D7	D6	D5	D4	D3	D2	D1	D0				
00C7	LOL1_EN	LOL0_EN	HOLD1_EN HOLD0_EN LOS3_EN LOS2_EN LOS1_EN LOS0_EN									
Interrupt Enable Control Register Block Field Descriptions												
Bit Field Name	Field Type	Default Value	Description	Description								
LOLm_EN	R/W	Ob	0 = LOLm_	Interrupt Enable Control for Loss-of-Lock Interrupt Status Bit for PLLm: 0 = LOLm_INT register bit will not affect status of nINT output signal 1 = LOLm_INT register bit will affect status of nINT output signal								
HOLDm_EN	R/W	Ob	0 = HOLDm	nable Control fo n_INT register b n_INT register b	oit will not affec	t status of nINT	output signal					
LOSm_EN	R/W	Ob	0 = LOSm_	 1 = HOLDm_INT register bit will affect status of nINT output signal Interrupt Enable Control for Loss-of-Signal Interrupt Status Bit for Input Reference m: 0 = LOSm_INT register bit will not affect status of nINT output signal 1 = LOSm_INT register bit will affect status of nINT output signal 								

		Digital Phase D	etector Con	trol Register	Block Field Lo	cations				
Address (Hex)	D7	D6	D5	D4	D3	D2	D1	D0		
00C8				2	:7h					
00C9		Rsvd		1	Rsvd	1	Rsvd	Rsvd		
00CA		27h								
00CB		Rsvd		1	Rsvd	1	Rsvd	Rsvd		
	1	igital Phase De	1	-	Block Field Des	criptions				
Bit Field Name	Field Type	Default Value	Descriptio	Description						
Rsvd	R/W	-	 Reserved. Always write 0 to this bit location. Read values are not defined. 							

Table 7S. Digital Phase Detector Control Register Bit Field Locations and Descriptions

Table 7T. Interrupt Status Register Bit Field Locations and Descriptions

This register contains' sticky' bits for tracking the status of the various alarms. Whenever an alarm occurs, the appropriate Interrupt Status bit will be set. The Interrupt Status bit will remain asserted even after the original alarm goes away. The Interrupt Status bits remain asserted until explicitly cleared by a write of a '1' to the bit over the serial port. This type of functionality is referred to as Read / Write-1-to-Clear (R/W1C).

	Interrupt Status Register Block Field Locations											
Address (Hex)	D7	D6	D5	D4	D3	D2	D1	D0				
0200	LOL1_INT	LOL0_INT	HOLD1_INT	HOLD0_INT	LOS3_INT	LOS2_INT	LOS1_INT	LOS0_INT				
0201		Rsvd										
0202		Rsvd										
0203				Rsv	d							

	Interrupt Status Register Block Field Descriptions							
Bit Field Name	Field Type	Default Value	Description					
LOLm_INT	R/W1C	0b	Interrupt Status Bit for Loss-of-Lock on PLLm: 0 = No Loss-of-Lock alarm flag on PLLm has occurred since the last time this register bit was cleared. 1 = At least one Loss-of-Lock alarm flag on PLLm has occurred since the last time this register bit was cleared.					
HOLDm_INT	R/W1C	0b	Interrupt Status Bit for Holdover on PLLm: 0 = No Holdover alarm flag on PLLm has occurred since the last time this register bit was cleared. 1 = At least one Holdover alarm flag on PLLm has occurred since the last time this register bit was cleared.					
LOSm_INT	R/W1C	0b	Interrupt Status Bit for Loss-of-Signal on Input Reference m: 0 = No Loss-of-Signal alarm flag on Input Reference m has occurred since the last time this register bit was cleared. 1 = At least one Loss-of-Signal alarm flag on Input Reference m has occurred since the last time this register bit was cleared.					
Rsvd	R/W	-	Reserved. Always write 0 to this bit location. Read values are not defined.					

Output Phase Adjustment Status Register Block Field Locations									
Address (Hex)	D7	D6	D5	D4	D3	D2	D1	D0	
0204	PA_BUSY7	PA_BUSY6	PA_BUSY5	PA_BUSY4	PA_BUSY3	PA_BUSY2	PA_BUSY1	PA_BUSY0	
Output Phase Adjustment Status Register Block Field Descriptions									
Bit Field Name	Field Type	Default Va	lue Descrip	tion					
PA_BUSYm	R/O	-	0 = No p 1 = Phas	 Phase Adjustment Event Status for output Qm, nQm: 0 = No phase adjustment is currently in progress on output Qm, nQm 1 = Phase adjustment still in progress on output Qm, nQm. Do not initiate any nev phase adjustment at this time. 					

Table 7U. Output Phase Adjustment Status Register Bit Field Locations and Descriptions

The following register is included for debug purposes only. It shows the actual digital PLL0 state directly. This means that the bits may change rapidly as the DPLL operates. The fields in this register do not represent a "snapshot" in time, so they may be inconsistent with one another if the DPLL is rapidly changing at the time of reading. Fast changes in the status of the PLL cannot be captured by polling these bits, in which case, Renesas recommends using the Sticky Bits interrupts and GPIOs.

Table 7V. Digital PLL0 Status Register Bit Field Locations and Descriptions

Digital PLL0 Status Register Block Field Locations									
Address (Hex)	D7	D6	D5	D4	D3	D2	D1	D0	
0205		Rsvd		EXTLOS0	NO_REF0		CURR_REF0	[2:0]	
0206		Rsvd		PLL0LCK	Rsvd	Rsvd	SM_	STS0[1:0]	
0207	Rsvd Rsvd								
0208	Rsvd								
0209	Rsvd								
020A		Rsvd Rsvd							
020B					Rsvd				
020C					Rsvd				
020D					Rsvd				
020E					Rsvd				

	Digital PLL0 Status Register Block Field Descriptions							
Bit Field Name	Field Type	Default Value	Description					
EXTLOS0	R/O	-	External Loopback signal lost for PLL0: 0 = PLL0 has a valid feedback reference signal 1 = PLL0 has lost the external feedback reference signal and is no longer locked					
NO_REF0	R/O	-	Valid Reference Status for Digital PLL0: 0 = At least one valid Input Reference is present 1 = No valid Input References present					
CURR_REF0[2:0]	R/O	-	Currently Selected Reference Status for Digital PLL0: 000 - 011 = No reference currently selected 100 = Input Reference 0 (CLK0, nCLK0) selected 101 = Input Reference 1 (CLK1, nCLK1) selected 110 = Input Reference 2 (CLK2, nCLK2) selected 111 = Input Reference 3 (CLK3, nCLK3) selected					

	Digital PLL0 Status Register Block Field Descriptions								
Bit Field Name	Field Type	Default Value	Description						
PLL0LCK	R/O	-	Digital PLL0 phase error value is less than the LOCK window setting. Not asserted if PLL0 is in Synthesizer Mode.						
SM_STS0[1:0]	R/O	-	Current State of Digital PLL0: 00 = Reserved 01 = Freerun 10 = Normal 11 = Holdover						
Rsvd	R/W	-	Reserved. Always write 0 to this bit location. Read values are not defined.						

The following register is included for debug purposes only. It shows the actual digital PLL1 state directly. This means that the bits may change rapidly as the DPLL operates. The fields in this register do not represent a "snapshot" in time, so they may be inconsistent with one another if the DPLL is rapidly changing at the time of reading. Fast changes in the status of the PLL cannot be captured by polling these bits, in which case, Renesas recommends using the Sticky Bits interrupts and GPIOs.

Table 7W. Digital PLL1 Status Register Bit Field Locations and Descriptions

Digital PLL1 Status Register Block Field Locations											
Address (Hex)	D7	D7 D6 D5 D4 D3 D2 D1 D0									
020F		Rsvd		EXTLOS1	NO_REF1		CURR_REF1[2:0]			
0210		Rsvd		PLL1LCK	Rsvd	Rsvd	SM_	STS1[1:0]			
0211		Rsvd Rsvd									
0212		Rsvd									
0213					Rsvd						
0214				Rsvd				Rsvd			
0215					Rsvd						
0216					Rsvd						
0217					Rsvd						
0218					Rsvd						

	Digital PLL1 Status Register Block Field Descriptions								
Bit Field Name	Field Type	Default Value	Description						
EXTLOS1	R/O	-	External Loopback signal lost for PLL1: 0 = PLL1 has a valid feedback reference signal 1 = PLL1 has lost the external feedback reference signal and is no longer locked						
NO_REF1	R/O	-	Valid Reference Status for Digital PLL1: 0 = At least one valid Input Reference is present 1 = No valid Input References present						
CURR_REF1[2:0]	R/O	-	Currently Selected Reference Status for Digital PLL1: 000 - 011 = No reference currently selected 100 = Input Reference 0 (CLK0, nCLK0) selected 101 = Input Reference 1 (CLK1, nCLK1) selected 110 = Input Reference 2 (CLK2, nCLK2) selected 111 = Input Reference 3 (CLK3, nCLK3) selected						

	Digital PLL1 Status Register Block Field Descriptions								
Bit Field Name	Field Type	Default Value	Description						
PLL1LCK	R/O	-	Digital PLL1 phase error value is less than the LOCK window setting. Not asserted if PLL1 is in Synthesizer Mode.						
SM_STS1[1:0]	R/O	-	Current State of Digital PLL1: 00 = Reserved 01 = Freerun 10 = Normal 11 = Holdover						
Rsvd	R/W	-	Reserved. Always write 0 to this bit location. Read values are not defined.						

Table 7X. General Purpose Input Status Register Bit Field Locations and Descriptions

	Global Interrupt Status Register Block Field Locations								
Address (Hex)	D7	D6	D5	D4	D3	D2	D1	D0	
0219	GPI[7]	GPI[6]	GPI[5]	GPI[4]	GPI[3]	GPI[2]	GPI[1]	GPI[0]	
		General Purpo	ose Input Stati	us Register Bl	ock Field Des	criptions			
Bit Field Name	Field Type	Default Value	Description						
GPI[7:0]	R/O	-	- Shows current values on GPIO[7:0] pins that are configured as General-Purpose Inputs.						

Table 7Y. Global Interrupt Status Register Bit Field Locations and Descriptions

		Global	Interrupt Stat	us Register	Block Field Loca	itions			
Address (Hex)	D7	D6	D5 D4 D3 D2 D1 D0						
021A	÷	Rsv	/d		Rsvd			INT	
021B		Rsvd							
021C	Rs	svd			R	Rsvd			
021D	Rs	svd			R	svd			
021E			Rsvd			Rsvd	Rsvd	BOOTFAIL	
021F	Rsvd	Rsvd	Rsvd	Rsvd	nEEP_CRC	Rsvd	Rsvd	EEPDONE	

	Global Interrupt Status Register Block Field Descriptions								
Bit Field Name	Field Type	Default Value	Description						
INT	R/O	-	Device Interrupt Status: 0 = No Interrupt Status bits that are enabled are asserted (nINT pin released) 1 = At least one Interrupt Status bit that is enabled is asserted (nINT pin asserted low)						
BOOTFAIL	R/O	-	Reading of Serial EEPROM failed. Once set this bit is only cleared by reset.						
nEEP_CRC	R/O	-	EEPROM CRC Error (Active Low): 0 = EEPROM was detected and read, but CRC check failed - please reset the device via the nRST pin to retry (serial port is locked) 1 = No EEPROM CRC Error						
EEPDONE	R/O	-	Serial EEPROM Read cycle has completed. Once set this bit is only cleared by reset.						
Rsvd	R/W	-	Reserved. Always write 0 to this bit location. Read values are not defined.						

Absolute Maximum Ratings

NOTE: Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of the product at these conditions or any conditions beyond those listed in the *DC Characteristics or AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

Item	Rating
Supply Voltage, V _{CC}	3.63V
Inputs, V _I OSCI Other Input	0V to 2V -0.5V to V _{CC} + 0.5V
Outputs, V _O (Q[0:7], nQ[0:7])	-0.5V to V _{CCOX} + 0.5V
Outputs, V _O (GPIO[0:7], SDATA, SCLK, nINT)	-0.5V to V _{CC} + 0.5V
Outputs, I _O (Q[0:7], nQ[0:7]) Continuous Current Surge Current	40mA 65mA
Outputs, I _O (GPIO[0:7], SDATA, SCLK, nINT)) Continuous Current Surge Current	8mA 13mA
Junction Temperature, T _J	125°C
Storage Temperature, T _{STG}	-65°C to 150°C

NOTE: V_{CCOX} denotes V_{CCO0}, V_{CCO1}, V_{CCO2}, V_{CCO3}, V_{CCO4}, V_{CCO5}, V_{CCO6}, V_{CCO7}.

Supply Voltage Characteristics

Table 8A. Power Supply Characteristics, $V_{CC} = 3.3V \pm 5\%$, $V_{EE} = 0V$, $T_A = -40^{\circ}C$ to $85^{\circ}C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V _{CC}	Core Supply Voltage		3.135	3.3	3.465	V
V _{CCA}	Analog Supply Voltage		V _{CC} – 0.14	3.3	V _{CC}	V
I _{CC}	Core Supply Current; NOTE 1			82	100	mA
	Angles Sumply Currents	PLL0 and PLL1 Enabled		215	275	mA
I _{CCA}	Analog Supply Current; NOTE 1	Analog PLL1, Digital PLL1, and Calibration Logic for Analog PLL1 Disabled		127	187	mA
I _{EE}	Power Supply Current; NOTE 2	Q[0:7] Configured for LVPECL Logic Levels; Outputs Unloaded		583	735	mA

NOTE 1: I_{CC} and I_{CCA} are included in I_{EE} when Q[0:7] configured for LVPECL logic levels.

NOTE 2: Internal dynamic switching current at maximum $\mathrm{f}_{\mathrm{OUT}}$ is included.

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V _{CC}	Core Supply Voltage		2.375	2.5	2.625	V
V _{CCA}	Analog Supply Voltage		V _{CC} – 0.14	2.5	V _{CC}	V
I _{CC}	Core Supply Current; NOTE 1			79	95	mA
	Analog Supply Current;	PLL0 and PLL1 Enabled		208	270	mA
I _{CCA}	NOTE 1	Analog PLL1, Digital PLL1, and Calibration Logic for Analog PLL1 Disabled		123	182	mA
I _{EE}	Power Supply Current; NOTE 2	Q[0:7] Configured for LVPECL Logic Levels; Outputs Unloaded		553	700	mA

Table 8B. Power Supply Characteristics. $V_{CC} = 2.5V + 5\%$, $V_{EE} = 0V T_A = -40^{\circ}C$ to $85^{\circ}C$

NOTE 1: I_{CC} and I_{CCA} are included in I_{EE} when Q[0:7] configured for LVPECL logic levels.

NOTE 2: Internal dynamic switching current at maximum f_{OUT} is included.

Table 8C. Maximum Output Supply Current, V_{CC} = 3.3V ±5% or 2.5V ±5%, V_{EE} = 0V, T_A = -40°C to 85°C

		Test		V _{CCOx} = 3.3V ±5%				V _{CCOx} =	2.5V ±5%	1	V _{CCOx} = 1.8V ±5%	
Symbol	Parameter	Conditions	LVPECL	LVDS	HCSL	LVCMOS	LVPECL	LVDS	HCSL	LVCMOS	LVCMOS	Units
I _{CCO0}	Q0, nQ0 Output Supply Current	Outputs Unloaded	50	60	50	55	40	50	40	45	35	mA
I _{CCO1}	Q1, nQ1 Output Supply Current	Outputs Unloaded	50	60	50	55	40	50	40	45	35	mA
I _{CCO2}	Q2, nQ2 Output Supply Current	Outputs Unloaded	80	90	80	80	70	80	70	70	60	mA
I _{CCO3}	Q3, nQ3 Output Supply Current	Outputs Unloaded	80	90	80	80	70	80	70	70	60	mA
I _{CCO4}	Q4, nQ4 Output Supply Current	Outputs Unloaded	55	65	55	55	45	55	45	45	40	mA
I _{CCO5}	Q5, nQ5 Output Supply Current	Outputs Unloaded	55	65	55	55	45	55	45	45	40	mA
I _{CCO6}	Q6, nQ6 Output Supply Current	Outputs Unloaded	55	65	55	55	45	55	45	45	40	mA
I _{CCO7}	Q7, nQ7 Output Supply Current	Outputs Unloaded	55	65	55	55	45	55	45	45	40	mA

NOTE: Internal dynamic switching current at maximum f_{OUT} is included. NOTE: V_{CCOX} denotes V_{CCO0}, V_{CCO1}, V_{CCO2}, V_{CCO3}, V_{CCO4}, V_{CCO5}, V_{CCO6}, V_{CCO7}.

DC Electrical Characteristics

Table 9A. LVCMOS/LVTTL DC Characteristics, V_{EE} = 0V, T_A = -40°C to 85° C

Symbol	Paramet	er	Test Conditions	Minimum	Typical	Maximum	Units
V	Input Llie	h Voltaga	V _{CC} = 3.3V	2		V _{CC} +0.3	V
V _{IH}	Input Hig	ıh Voltage	V _{CC} = 2.5V	1.7		V _{CC} +0.3	V
V	Input Los	w)/oltaga	V _{CC} = 3.3V	-0.3		0.8	V
V _{IL}	Input Lov	w Voltage	V _{CC} = 2.5V	-0.3		0.7	V
	Input	nl2C_SPI, PLL_BYP, S_A0/nCS, S_A1/SDI	V _{CC} = V _{IN} = 3.465V or 2.625V			150	μA
I _{IH}	High Current	nRST, SDATA/SDO, nWP, SCLK/SCLK	V _{CC} = V _{IN} = 3.465V or 2.625V			5	μA
		GPIO[7:0]	V _{CC} = V _{IN} = 3.465V or 2.625V			1	mA
	Input	nl2C_SPI, PLL_BYP, S_A0/nCS, S_A1/SDI	V _{CC} = 3.465V or 2.625V, V _{IN} = 0V	-5			μA
I _{IL}	Low Current	nRST, SDATA/SDO, nWP, SCLK/SCLK	V _{CC} = 3.465V or 2.625V, V _{IN} = 0V	-150			μA
		GPIO[7:0]	V _{CC} = 3.465V or 2.625V, V _{IN} = 0V	-1			mA
		nINT, SDATA/SDO, SCLK/SCLK; NOTE 1	V _{CC} = 3.3V ±5%, I _{OH} = -5μA	2.6			V
V	Output	GPIO[7:0]	V _{CC} = 3.3V ±5%, I _{OH} = -50µA	2.6			V
V _{OH}	High Voltage	nINT, SDATA/SDO, SCLK/SCLK; NOTE 1	V _{CC} = 2.5V ±5%, I _{OH} = -5μA	1.8			V
	GPIO[7:0]	V _{CC} = 2.5V ±5%, I _{OH} = -50μA	1.8			V	
V _{OL}	Output Low	nINT, SDATA/SDO, SCLK/SCLK; NOTE 1	V _{CC} = 3.3V ±5% or 2.5V ±5%, I _{OL} = 5mA			0.5	V
	Voltage	GPIO[7:0]	V _{CC} = 3.3V ±5% or 2.5V ±5%, I _{OL} = 5mA			0.5	V

NOTE 1: Use of external pull-up resistors is recommended.

Table 9B. Differential Input DC Characteristics, V_{CC} = 3.3V ±5% or 2.5V ±5%, V_{EE} = 0V, T_A = -40°C to 85°C

Symbol	CLKx.		Test Conditions	Minimum	Typical	Maximum	Units
I _{IH}			V _{CC} = V _{IN} = 3.465V or 2.625V			150	μA
	Input Low Current	CLKx	V_{CC} = 3.465V or 2.625V, V_{IN} = 0V	-5			μA
ιL	Input Low Current	nCLKx	V_{CC} = 3.465V or 2.625V, V_{IN} = 0V	-150			μA
V _{PP}	Peak-to-Peak Voltag	e; NOTE 1		0.15		1.3	V
V _{CMR}	Common Mode Input NOTE 1, 2	t Voltage;		V_{EE}		V _{CC} -1.2	V

NOTE: CLKx denotes CLK0, CLK1, CLK2, CLK3. nCLKx denotes nCLK0, nCLK1, nCLK2, nCLK3.

NOTE 1: V_{IL} should not be less than -0.3V. V_{IH} should not be higher than V_{CC}.

NOTE 2: Common mode voltage is defined as the cross-point.

						·	-			
				V _{CC}	±5%	V _{cc}	_{Ox} = 2.5V	±5%		
Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Minimum	Typical	Maximum	Units
V _{OH}	Output High Voltage; NOTE 1	Qx, nQx		V _{CCOx} - 1.3		V _{CCOx} - 0.8	V _{CCOx} - 1.4		V _{CCOx} - 0.9	v
V _{OL}	Output Low Voltage; NOTE 1	Qx, nQx		V _{CCOx} - 1.95		V _{CCOx} - 1.75	V _{CCOx} - 1.95		V _{CCOx} - 1.75	v

Table 9C. LVPECL DC Characteristics, V_{CC} = 3.3V ±5% or 2.5V ±5%, V_{EE} = 0V, T_A = -40°C to 85°C

NOTE: V_{CCOx} denotes V_{CCO0}, V_{CCO1}, V_{CCO2}, V_{CCO3}, V_{CCO4}, V_{CCO5}, V_{CCO6}, V_{CCO7}. NOTE: Qx denotes Q0, Q1, Q2, Q3, Q4, Q5, Q6, Q7. nQx denotes nQ0, nQ1, nQ2, nQ3, nQ4, nQ5, nQ6, nQ7.

NOTE 1: Outputs terminated with 50Ω to V_{CCOx} – 2V.

Table 9D. LVDS DC Characteristics, V_{CC} = 3.3V ±5% or 2.5V ±5%, V_{CCOx} = 3.3V ±5% or 2.5V ±5%, V_{EE} = 0V, T_A = -40°C to 85°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
V _{OD}	Differential Output Voltage	Qx, nQx		195		454	mV
ΔV_{OD}	V _{OD} Magnitude Change	Qx, nQx				50	mV
V _{OS}	Offset Voltage	Qx, nQx		1.1		1.375	V
ΔV_{OS}	V _{OS} Magnitude Change	Qx, nQx				50	mV

NOTE: V_{CCOx} denotes V_{CCO0}, V_{CCO1}, V_{CCO2}, V_{CCO3}, V_{CCO4}, V_{CCO5}, V_{CCO6}, V_{CCO7}. NOTE: Qx denotes Q0, Q1, Q2, Q3, Q4, Q5, Q6, Q7. nQx denotes nQ0, nQ1, nQ2, nQ3, nQ4, nQ5, nQ6, nQ7.

NOTE: Terminated 100Ω across Qx and nQx.

Table 9E. LVCMOS DC Characteristics, V_{CC} = 3.3V ±5% or 2.5V ±5%, V_{EE} = 0V, T_A = -40°C to 85°C

			Test	V _{CC}	_{Dx} = 3.3V	′±5%	V _{CCC}	_{Dx} = 2.5V	′±5%	V _{ccc}	_{Dx} = 1.8V	′ ±5%	
Symbol	Parameter		Conditions	Minimum	Typical	Maximum	Minimum	Typical	Maximum	Minimum	Typical	Maximum	Units
V _{OH}	Output High Voltage	Qx, nQx	I _{OH} = -8mA	2.6			1.8			1.1			V
V _{OL}	Output Low Voltage	Qx, nQx	I _{OL} = 8mA			0.5			0.5			0.5	V

 $\begin{array}{l} \text{NOTE: } V_{\text{CCOx}} \text{ denotes } V_{\text{CCO0},} V_{\text{CCO1},} V_{\text{CCO2},} V_{\text{CCO3},} V_{\text{CCO4},} V_{\text{CCO5},} V_{\text{CCO6},} V_{\text{CCO7}.} \\ \text{NOTE: } \text{Qx denotes } \text{Q0, } \text{Q1, } \text{Q2, } \text{Q3, } \text{Q4, } \text{Q5, } \text{Q6, } \text{Q7. } \text{nQx denotes } \text{nQ0, } \text{nQ1, } \text{nQ2, } \text{nQ3, } \text{nQ4, } \text{nQ5, } \text{nQ6, } \text{nQ7.} \end{array}$

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
			Using a crystal (See Table 11, Crystal Characteristics)	10		40	MHz
	Input Frequency;	OSCI, OSCO	Overdriving Crystal Input, Doubler Logic Enabled; NOTE 2	10		62.5	MHz
	NOTE 1		Overdriving Crystal Input, Doubler Logic Disabled; NOTE 2	16		125	MHz
		CLKx, nCLKx		0.008		875	MHz
£	Serial Port Clock	I ² C Operation		100		400	kHz
f _{SCLK}	SCLK (slave mode)	SPI Operation				4.25	MHz

NOTE: CLKx denotes CLK0, CLK1, CLK2, CLK3. nCLKx denotes nCLK0, nCLK1, nCLK2, nCLK3.

NOTE 1: For the input reference frequency, the divider values must be set for the VCO to operate within its supported range.

NOTE 2: For optimal noise performance, the use of a quartz crystal is recommended. Refer to Applications Information, Overdriving the XTAL Interface.

Table 11. Crystal Characteristics

Parameter	Test Conditions	Minimum	Typical	Maximum	Units
Mode of Oscillation			Fundamental		
Frequency		10		40	MHz
Equivalent Series Resistance (ESR)			15		Ω
Load Capacitance (C _L)			12		pF
Frequency Stability (total)		-100		100	ppm

AC Electrical Characteristics

Table 12. AC Characteristics, V_{CC} = $3.3V \pm 5\%$ or $2.5V \pm 5\%$, V_{CCOx} = $3.3V \pm 5\%$, $2.5V \pm 5\%$ or $1.8V \pm 5\%$ (1.8V only supported for LVCMOS outputs), T_A = -40°C to 85° C

Symbol	Parameter			Test Conditions	Minimum	Typical	Maximum	Units
f _{VCO}	VCO Operating Frequency				3000		4000	MHz
				Q0, Q1, Q4, Q5, Q6, Q7 Outputs	0.008		1000	MHz
£	Output	LVPECL, LVDS, HCSL		Q2, Q3 Outputs Integer Divide Ratio & No Added Phase Delay	0.008		666.67	MHz
fout	Frequency			Q2, Q3 Outputs Non-integer Divide and/or Added Phase Delay	0.008		400	MHz
		LVCMOS			0.008		250	MHz
		LVPECL		20% to 80%	145	360	600	ps
		LVDS		20% to 80%	100	230	400	ps
	Output	HCSL		20% to 80%	150	300	600	ps
t _R / t _F	Rise and Fall Times			20% to 80%, V _{CCOx} = 3.3V	180	350	600	ps
		LVCMOS; NOTE 1, 2		20% to 80%, V _{CCOx} = 2.5V	200	350	550	ps
				20% to 80%, V _{CCOx} = 1.8V	200	410	650	ps
		LVPECL		Measured on Differential Waveform, ±150mV from Center	1		5	V/ns
	Output	LVDS		Measured on Differential Waveform, ±150mV from Center	0.5		4	V/ns
SR	Slew Rate; NOTE 3	HCSL		$\begin{array}{l} \mbox{Measured on Differential} \\ \mbox{Waveform, } \pm 150 \mbox{mV from Center,} \\ \mbox{V}_{CCOx} = 2.5 \mbox{V, } f_{OUT} \ \le 125 \mbox{MHz} \end{array}$	1.5		4	V/ns
		HUSL		$\begin{array}{l} \mbox{Measured on Differential} \\ \mbox{Waveform, } \pm 150 \mbox{mV from Center,} \\ \mbox{V}_{CCOx} = 3.3 \mbox{V}, f_{OUT} \ \le 125 \mbox{MHz} \end{array}$	2.5		5.5	V/ns
			Q0, nQ0; Q1, nQ1	NOTE 4, 5, 6, 7			75	ps
		LVPECL	Q4, nQ4; Q5, nQ5	NOTE 4, 5, 6, 7			75	ps
			Q6, nQ6; Q7, nQ7	NOTE 4, 5, 6, 7			75	ps
			Q0, nQ0; Q1, nQ1	NOTE 4, 5, 6, 7			75	ps
		LVDS	Q4, nQ4; Q5, nQ5	NOTE 4, 5, 6, 7			75	ps
f= 1 (/ h)	Bank		Q6, nQ6; Q7, nQ7	NOTE 4, 5, 6, 7			75	ps
<i>t</i> sk(b)	Skew		Q0, nQ0; Q1, nQ1	NOTE 4, 5, 6, 7			75	ps
		HCSL	Q4, nQ4; Q5, nQ5	NOTE 4, 5, 6, 7			75	ps
			Q6, nQ6; Q7, nQ7	NOTE 4, 5, 6, 7			75	ps
			Q0, nQ0; Q1, nQ1	NOTE 1, 4, 5, 7, 8			80	ps
		LVCMOS	Q4, nQ4; Q5, nQ5	NOTE 1, 4, 5, 7, 8			115	ps
			Q6, nQ6; Q7, nQ7	NOTE 1, 4, 5, 7, 8			115	ps
	Output			$f_{OUT} \le 666.667 MHz$	45	50	55	%
odc	Duty Cycle;	LVPECL,	LVDS, HCSL	f _{OUT} > 666.667MHz	40	50	60	%
	NOTE 9	LVCMOS			40	50	60	%

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
	Initial Frequency Offse	et	Switchover or Entering / Leaving Holdover State; NOTE 10, 11, 12	-50		50	ppb
	Output Phase Change Switching	e in Fully Hitless	Switchover or Entering / Leaving Holdover State; NOTE 11, 12. 13		5		ns
$\Phi_{\text{SSB}}(1k)$		1kHz	122.88MHz Output		-106		dBc/Hz
$\Phi_{\text{SSB}}(10\text{k})$	-	10kHz	122.88MHz Output		-126		dBc/Hz
$\Phi_{\text{SSB}}(100\text{k})$	Single Sideband Phase Noise;	100kHz	122.88MHz Output		-134		dBc/Hz
$\Phi_{\text{SSB}}(1\text{M})$	NOTE 14	1MHz	122.88MHz Output		-148		dBc/Hz
$\Phi_{\text{SSB}}(10\text{M})$		10MHz	122.88MHz Output		-155		dBc/Hz
$\Phi_{\text{SSB}}(30\text{M})$	-	≥30MHz	122.88MHz Output		-156		dBc/Hz
	Spurious Limit at Offset	≥800kHz	122.88MHz Output; NOTE 15		-85		dBc
		Internal OTP Startup; NOTE 11	from V _{CC} >80% to First Output Clock Edge		110	150	ms
			from V _{CC} >80% to First Output Clock Edge (0 retries). I ² C Frequency = 100kHz		150	200	ms
<i>t</i> startup	Startup Time	External EEPROM Startup;	from V _{CC} >80% to First Output Clock Edge (0 retries). I ² C Frequency = 400kHz		130	150	ms
		NOTE 11, 16	from V _{CC} >80% to First Output Clock Edge (31 retries). I ² C Frequency = 100kHz		925	1200	ms
			from V _{CC} >80% to First Output Clock Edge (31 retries). I ² C Frequency = 400kHz		360	500	ms
∆SPO	Static Phase Offset Va	ariation	f _{IN} = f _{OUT} = 156.25 MHz; NOTE 17	-175		175	ps

NOTE: V_{CCOx} denotes V_{CCO0}, V_{CCO1}, V_{CCO2}, V_{CCO3}, V_{CCO4}, V_{CCO5}, V_{CCO6}, V_{CCO7}.

NOTE: Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

NOTE 1: Appropriate SE_MODE bit must be configured to select phase-aligned or phase-inverted operation.

NOTE 2: All Q and nQ outputs in phase-inverted operation.

NOTE 3: Measured from -150mV to +150mV on the differential waveform (derived from Qx minus nQx). The signal must be monotonic through the measurement region for rise and fall time. The 300mV measurement window is centered on the differential zero crossing. NOTE 4: This parameter is guaranteed by characterization. Not tested in production.

NOTE 5: This parameter is defined in accordance with JEDEC Standard 65.

NOTE 6: Measured at the output differential crosspoints.

NOTE 7: Defined as skew within a bank of outputs at the same supply voltage and with equal load conditions running off the same PLL.

NOTE 8: Measured at V_{CCOx}/2 of the rising edge. All Qx and nQx outputs phase-aligned.

NOTE 9: Characterized in synthesizer mode. Duty cycle of bypassed signals (input reference clocks or crystal input) is not adjusted by the device.

NOTE 10: Tested in fast-lock operation after >20 minutes of locked operation to ensure holdover averaging logic is stable.

NOTE 11: This parameter is guaranteed by design.

NOTE 12: Using internal feedback mode configuration.

NOTE 13: Device programmed with SWMODEn = 0 (absorbs phase differences).

NOTE 14: Characterized with 8T49N286-901 units (synthesizer mode).

NOTE 15: Tested with all outputs operating at 122.88MHz.

NOTE 16: Assuming a clear I²C bus.

NOTE 17: This parameter was measured using CLK2 as the reference input and CLK1 as the external feedback input. Characterized with 8T49N286-908.

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V _{RB}	Ring-back Voltage Margin; NOTE 1, 2		-100		100	mV
t _{STABLE}	Time before V _{RB} is allowed; NOTE 1, 2		500			ps
V _{MAX}	Absolute Max. Output Voltage; NOTE 3, 4				1150	mV
V _{MIN}	Absolute Min. Output Voltage; NOTE 3, 5		-300			mV
V _{CROSS}	Absolute Crossing Voltage; NOTE 6, 7		230		550	mV
ΔV_{CROSS}	Total Variation of V _{CROSS} over all edges; NOTE 6, 8				140	mV

Table 13. HCSL AC Characteristics, $V_{CC} = 3.3V \pm 5\%$ or 2.5V $\pm 5\%$, $V_{CCOx} = 3.3V \pm 5\%$ or 2.5V $\pm 5\%$, $T_A = -40^{\circ}$ C to 85°C

NOTE: Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

NOTE 1: Measurement taken from differential waveform.

NOTE 2: T_{STABLE} is the time the differential clock must maintain a minimum ±150mV differential voltage after rising/falling edges before it is allowed to drop back into the V_{RB} ±100mV differential range.

NOTE 3: Measurement taken from single ended waveform.

NOTE 4: Defined as the maximum instantaneous voltage including overshoot.

NOTE 5: Defined as the minimum instantaneous voltage including undershoot.

NOTE 6: Measured at crossing point where the instantaneous voltage value of the rising edge of Qn equals the falling edge of nQn.

NOTE 7: Refers to the total variation from the lowest crossing point to the highest, regardless of which edge is crossing. Refers to all crossing points for this measurement.

NOTE 8: Defined as the total variation of all crossing voltages of rising Qn and falling nQn. This is the maximum allowed variance in V_{CROSS} for any particular system.

Table 14A. Typical RMS Phase Jitter (Synthesizer Mode), V_{CC} = 3.3V ±5% or 2.5V ±5%, V_{CCOx} = 3.3V ±5%, 2.5V ±5% or 1.8V \pm 5% (1.8V only supported for LVCMOS outputs), T_A = -40°C to 85°C

Symbol	Parameter		Test Conditions	LVPECL	LVDS	HCSL	LVCMOS NOTE 6	Units
			f _{OUT} = 122.88MHz, Integration Range: 12kHz - 20MHz; NOTE 1	266	271	260	293	fs
		Q0, Q1	f _{OUT} = 156.25MHz, Integration Range: 12kHz - 20MHz; NOTE 2	271	268	267	255	fs
+;;+(+)	RMS Phase Jitter		f _{OUT} = 622.08MHz, Integration Range: 12kHz - 20MHz; NOTE 3	285	252	252	N/A (NOTE 5)	fs
tjit(φ)	(Random)	Q2, Q3 Integer; NOTE 1	f _{OUT} = 122.88MHz, Integration Range: 12kHz - 20MHz	291	293	284	315	fs
		Q2, Q3 Fractional; NOTE 4	f _{OUT} = 122.88MHz, Integration Range: 12kHz - 20MHz	263	265	253	261	fs
		Q4, Q5, Q6, Q7; NOTE 1	f _{OUT} = 122.88MHz, Integration Range: 12kHz - 20MHz	281	284	274	308	fs

NOTE: V_{CCOx} denotes V_{CCO0}, V_{CCO1}, V_{CCO2}, V_{CCO3}, V_{CCO4}, V_{CCO5}, V_{CCO6}, V_{CCO7}. NOTE: Fox part numbers: 277LF-40-18 and 277LF-38.88-2 used for 40MHz and 38.88MHz crystals, respectively.

NOTE: All outputs configured for the specific output type, as shown in the table.

NOTE 1: Characterized with 8T49N286-901.

NOTE 2: Characterized with 8T49N286-902.

NOTE 3: Characterized with 8T49N286-903.

NOTE 4: Characterized with 8T49N286-900.

NOTE 5: This frequency is not supported for LVCMOS operation.

NOTE 6: Qx and nQx are 180° out of phase.

Table 14B. Typical RMS Phase Jitter (Jitter Attenuator Mode), $V_{CC} = 3.3V \pm 5\%$ or 2.5V $\pm 5\%$, $V_{CCOx} = 3.3V \pm 5\%$, 2.5V $\pm 5\%$ or 1.8V $\pm 5\%$ (1.8V only supported for LVCMOS outputs), $T_A = -40$ °C to 85°C

Symbol	Parameter		Test Conditions	LVPECL	LVDS	HCSL	LVCMOS NOTE 6	Units
			f _{OUT} = 122.88MHz, Integration Range: 12kHz - 20MHz; NOTE 1	281	291	286	283	fs
		Q0, Q1	f _{OUT} = 156.25MHz, Integration Range: 12kHz - 20MHz; NOTE 2	253	247	249	253	fs
tiit(+)	RMS Phase Jitter		f _{OUT} = 622.08MHz, Integration Range: 12kHz - 20MHz; NOTE 3	230	202	202	N/A (NOTE 5)	fs
tjit(φ)	(Random)	Q2, Q3 Integer; NOTE 1	f _{OUT} = 122.88MHz, Integration Range: 12kHz - 20MHz	294	299	293	302	fs
		Q2, Q3 Fractional; NOTE 4	f _{OUT} = 122.88MHz, Integration Range: 12kHz - 20MHz	264	265	255	262	fs
		Q4, Q5, Q6, Q7; NOTE 1	f _{OUT} = 122.88MHz, Integration Range: 12kHz - 20MHz	302	304	304	282	fs

NOTE: V_{CCOx} denotes V_{CCO0} , V_{CCO1} , V_{CCO2} , V_{CCO3} , V_{CCO4} , V_{CCO5} , V_{CCO6} , V_{CCO7} . NOTE: Measured using a Rohde & Schwarz SMA100A as the input source.

NOTE: Fox part numbers: 277LF-40-18 and 277LF-38.88-2 used for 40MHz and 38.88MHz crystals, respectively.

NOTE: All outputs configured for the specific output type, as shown in the table.

NOTE 1: Characterized with 8T49N286-905.

NOTE 2: Characterized with 8T49N286-906.

NOTE 3: Characterized with 8T49N286-907.

NOTE 4: Characterized with 8T49N286-904.

NOTE 5: This frequency is not supported for LVCMOS operation.

NOTE 6: Qx and nQx are 180° out of phase.

Table 15. PCI Express Jitter Specifications, V_{CC} = 3.3V ±5% or 2.5V ±5%, V_{CCOx} = 3.3V ±5% or 2.5V ±5%, $T_A = -40^{\circ}C$ to $85^{\circ}C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	PCIe Industry Specification	Units
tj (PCIe Gen 1)	Phase Jitter Peak-to-Peak; NOTE 1, 4, 5	<i>f</i> = 100MHz, 40MHz Crystal Input, Evaluation Band: 0Hz - Nyquist (clock frequency/2)		8	16	86	ps
^t REFCLK_HF_RMS (PCIe Gen 2)	Phase Jitter RMS; NOTE 2, 4, 5	f = 100MHz, 40MHz Crystal Input, High Band: 1.5MHz - Nyquist (clock frequency/2)		0.8	1.8	3.1	ps
^t REFCLK_LF_RMS (PCIe Gen 2)	Phase Jitter RMS; NOTE 2, 4, 5	f = 100MHz, 40MHz Crystal Input, Low Band: 10kHz - 1.5MHz		0.03	0.5	3.0	ps
^t REFCLK_RMS (PCIe Gen 3)	Phase Jitter RMS; NOTE 3, 4, 5	f = 100MHz, 40MHz Crystal Input, Evaluation Band: 0Hz - Nyquist (clock frequency/2)		0.2	0.5	0.8	ps

NOTE: V_{CCOx} denotes V_{CCO0}, V_{CCO1}, V_{CCO2}, V_{CCO3}, V_{CCO4}, V_{CCO5}, V_{CCO6}, V_{CCO7}. NOTE: Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

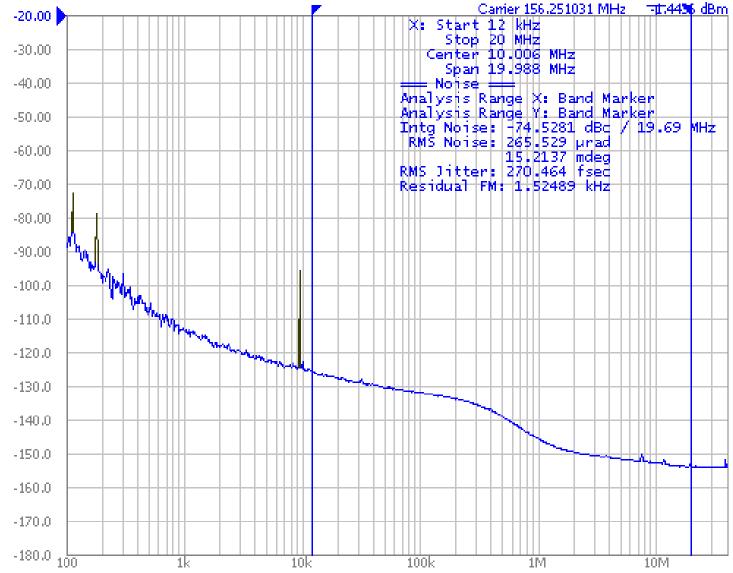
NOTE 1: Peak-to-Peak jitter after applying system transfer function for the Common Clock Architecture. Maximum limit for PCI Express Gen 1 NOTE 2: RMS jitter after applying the two evaluation bands to the two transfer functions defined in the Common Clock Architecture and reporting the worst case results for each evaluation band. Maximum limit for PCI Express Generation 2 is 3.1ps RMS for tREFCLK HF RMS (High Band) and 3.0ps RMS for $t_{REFCLK_LF_RMS}$ (Low Band).

NOTE 3: RMS jitter after applying system transfer function for the common clock architecture. This specification is based on the PCI Express Base Specification Revision 0.7, October 2009 and is subject to change pending the final release version of the specification. NOTE 4: This parameter is guaranteed by characterization. Not tested in production.

NOTE 5: Outputs configured for HCSL mode. Fox 277LF-40-18 crystal used with doubler logic enabled.

Typical Phase Noise at 156.25MHz

Phase Noise 10.00dB/ Ref -20.00dBc/Hz



Applications Information

Overdriving the XTAL Interface

The OSCI input can be overdriven by an LVCMOS driver or by one side of a differential driver through an AC coupling capacitor. The OSCO pin can be left floating. The amplitude of the input signal should be between 500mV and 1.8V and the slew rate should not be less than 0.2V/ns. For 3.3V LVCMOS inputs, the amplitude must be reduced from full swing to at least half the swing in order to prevent signal interference with the power rail and to reduce internal noise. *Figure 8A* shows an example of the interface diagram for a high speed 3.3V LVCMOS driver. This configuration requires that the sum of the output impedance of the driver (Ro) and the series resistance (Rs) equals the transmission line impedance. In addition, matched termination at the crystal input will attenuate the signal in half. This can be done in one of two ways. First, R1 and R2 in parallel should

equal the transmission line impedance. For most 50Ω applications, R1 and R2 can be 100Ω . This can also be accomplished by removing R1 and changing R2 to 50Ω . The values of the resistors can be increased to reduce the loading for a slower and weaker LVCMOS driver. *Figure 8B* shows an example of the interface diagram for an LVPECL driver. This is a standard LVPECL termination with one side of the driver feeding the OSCI input. It is recommended that all components in the schematics be placed in the layout. Though some components might not be used, they can be utilized for debugging purposes. Input signal duty cycle worse than 50% will result in phase noise degradation. The datasheet specifications are characterized and guaranteed by using a quartz crystal as the input.

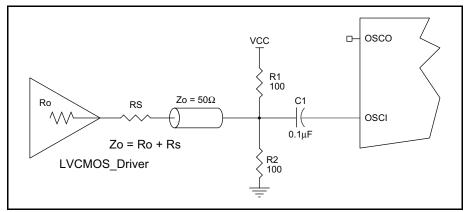


Figure 8A. General Diagram for LVCMOS Driver to XTAL Input Interface

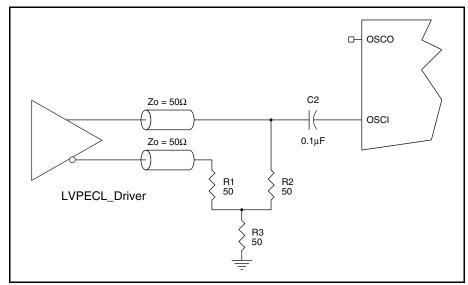


Figure 8B. General Diagram for LVPECL Driver to XTAL Input Interface

Wiring the Differential Input to Accept Single-Ended Levels

Figure 9 shows how a differential input can be wired to accept single ended levels. The reference voltage $V_1 = V_{CC}/2$ is generated by the bias resistors R1 and R2. The bypass capacitor (C1) is used to help filter noise on the DC bias. This bias circuit should be located as close to the input pin as possible. The ratio of R1 and R2 might need to be adjusted to position the V1 in the center of the input voltage swing. For example, if the input clock swing is 2.5V and V_{CC} = 3.3V, R1 and R2 value should be adjusted to set V1 at 1.25V. Similarly, if the input clock swing is 1.8V and V_{CC} = 3.3V, R1 and R2 value should be adjusted to set V1 at 0.9V. It is recommended to always use R1 and R2 to provide a known V_1 voltage. The values below are for when both the single ended swing and V_{CC} are at the same voltage. This configuration requires that the sum of the output impedance of the driver (Ro) and the series resistance (Rs) equals the transmission line impedance. In addition, matched termination at the input will attenuate the signal in half. This can be done in one of two ways.

First, R3 and R4 in parallel should equal the transmission line impedance. For most 50 Ω applications, R3 and R4 can be 100 Ω . The values of the resistors can be increased to reduce the loading for slower and weaker LVCMOS driver. When using single-ended signaling, the noise rejection benefits of differential signaling are reduced. Even though the differential input can handle full rail LVCMOS signaling, it is recommended that the amplitude be reduced. The datasheet specifies a lower differential amplitude, however this only applies to differential signals. For single-ended applications, the swing can be larger, however $V_{\mbox{\scriptsize IL}}$ cannot be less than -0.3V and V_{IH} cannot be more than V_{CC} + 0.3V. Suggest edge rate faster than 1V/ns. Though some of the recommended components might not be used, the pads should be placed in the layout. They can be utilized for debugging purposes. The datasheet specifications are characterized and guaranteed by using a differential signal.

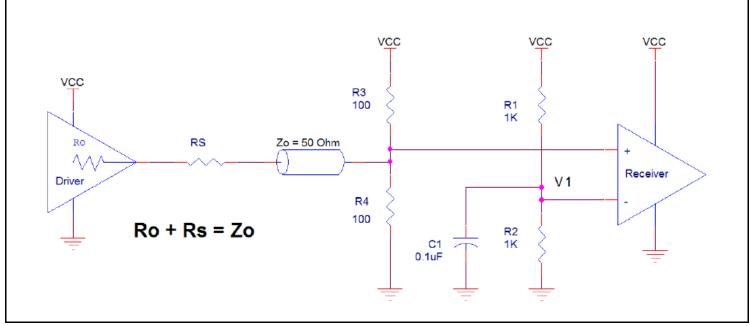


Figure 9. Recommended Schematic for Wiring a Differential Input to Accept Single-ended Levels

3.3V Differential Clock Input Interface

CLKx/nCLKx accepts LVDS, LVPECL, LVHSTL, HCSL and other differential signals. Both V_{SWING} and V_{OH} must meet the V_{PP} and V_{CMR} input requirements. *Figure 10A* to *Figure 10E* show interface examples for the CLKx/nCLKx input driven by the most common driver types. The input interfaces suggested here are examples only.

Please consult with the vendor of the driver component to confirm the driver termination requirements. For example, in *Figure 10A*, the input termination applies for Renesas open emitter LVHSTL drivers. If you are using an LVHSTL driver from another vendor, use their termination recommendation.

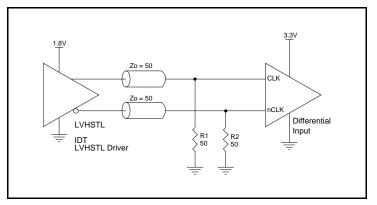


Figure 10A. CLKx/nCLKx Input Driven by a Renesas Open Emitter LVHSTL Driver

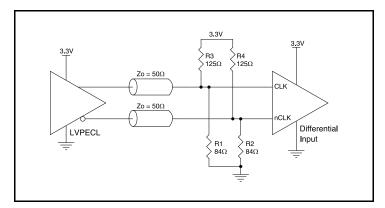


Figure 10B. CLKx/nCLKx Input Driven by a 3.3V LVPECL Driver

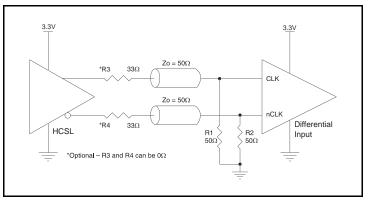
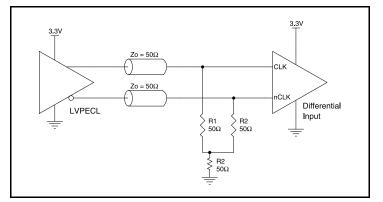


Figure 10C. CLKx/nCLKx Input Driven by a 3.3V HCSL Driver





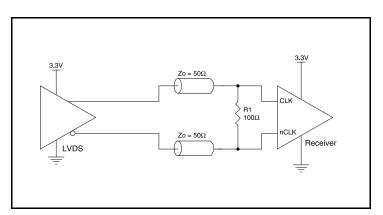


Figure 10E. CLKx/nCLKx Input Driven by a 3.3V LVDS Driver

2.5V Differential Clock Input Interface

CLKx/nCLKx accepts LVDS, LVPECL, LVHSTL and other differential signals. Both V_{SWING} and V_{OH} must meet the V_{PP} and V_{CMR} input requirements. *Figure 11A* to *Figure 11D* show interface examples for the CLKx/nCLKx input driven by the most common driver types. The input interfaces suggested here are examples only. Please consult

with the vendor of the driver component to confirm the driver termination requirements. For example, in *Figure 11A*, the input termination applies for Renesas open emitter LVHSTL drivers. If you are using an LVHSTL driver from another vendor, use their termination recommendation.

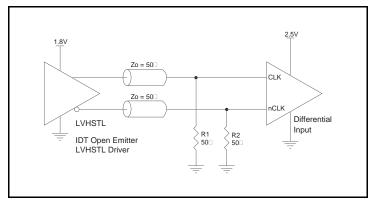


Figure 11A. CLKx/nCLKx Input Driven by a Renesas Open Emitter LVHSTL Driver

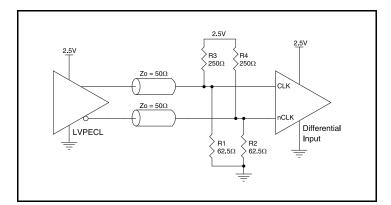
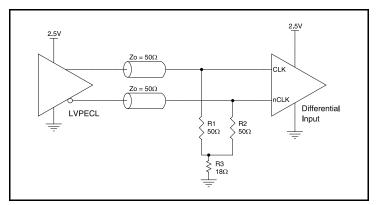


Figure 11B. CLKx/nCLKx Input Driven by a 2.5V LVPECL Driver





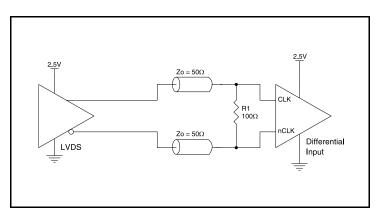


Figure 11D. CLKx/nCLKx Input Driven by a 2.5V LVDS Driver

Recommendations for Unused Input and Output Pins

Inputs

CLKx/nCLKx Input

For applications not requiring the use of one or more reference clock inputs, both CLKx and nCLKx can be left floating. Though not required, but for additional protection, a $1k\Omega$ resistor can be tied from CLKx to ground. It is recommended that CLKx, nCLKx not be driven with active signals when not enabled for use by either PLL.

LVCMOS Control Pins

All control pins have internal pullup or pulldown resistors; additional resistance is not required but can be added for additional protection. A $1k\Omega$ resistor can be used.

Outputs

LVPECL Outputs

Any unused LVPECL output pair can be left floating. We recommend that there is no trace attached. Both sides of the differential output pair should either be left floating or terminated.

LVDS Outputs

Any unused LVDS output pair can be either left floating or terminated with 100Ω across. If they are left floating there should be no trace attached.

LVCMOS Outputs

Any LVCMOS output can be left floating if unused. There should be no trace attached.

LVDS Driver Termination

For a general LVDS interface, the recommended value for the termination impedance (Z_T) is between 90 Ω and 132 Ω . The actual value should be selected to match the differential impedance (Z_0) of your transmission line. A typical point-to-point LVDS design uses a 100 Ω parallel resistor at the receiver and a 100 Ω differential transmission-line environment. In order to avoid any transmission-line reflection issues, the components should be surface mounted and must be placed as close to the receiver as possible. Renesas offers a full line of LVDS compliant devices with two types of output structures: current source and voltage source. The standard termination schematic as shown in *Figure 12A* can be

used with either type of output structure. *Figure 12B*, which can also be used with both output types, is an optional termination with center tap capacitance to help filter common mode noise. The capacitor value should be approximately 50pF. If using a non-standard termination, it is recommended to contact Renesas and confirm if the output structure is current source or voltage source type. In addition, since these outputs are LVDS compatible, the input receiver's amplitude and common-mode input range should be verified for compatibility with the output.

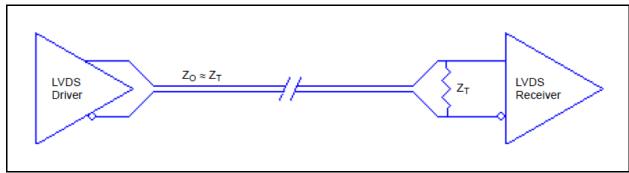


Figure 12A.Standard LVDS Termination

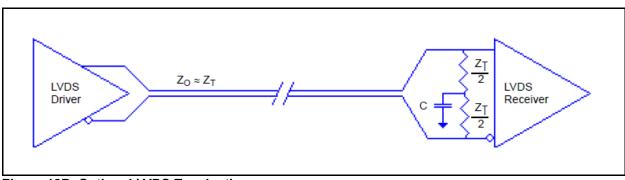


Figure 12B. Optional LVDS Termination

Termination for 3.3V LVPECL Outputs

The clock layout topology shown below is a typical termination for LVPECL outputs. The two different layouts mentioned are recommended only as guidelines.

The differential outputs generate ECL/LVPECL compatible outputs. Therefore, terminating resistors (DC current path to ground) or current sources must be used for functionality. These outputs are

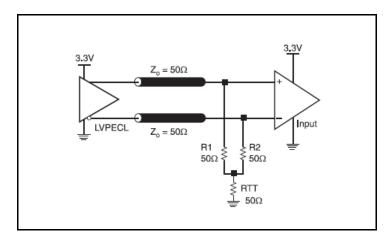


Figure 13A. 3.3V LVPECL Output Termination

designed to drive 50Ω transmission lines. Matched impedance techniques should be used to maximize operating frequency and minimize signal distortion. *Figure 13A* and *Figure 13B* show two different layouts which are recommended only as guidelines. Other suitable clock layouts may exist and it would be recommended that the board designers simulate to guarantee compatibility across all printed circuit and clock component process variations.

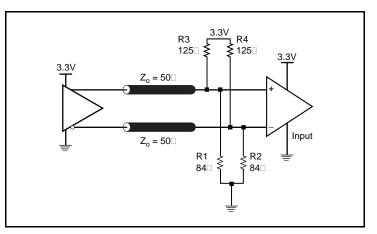


Figure 13B. 3.3V LVPECL Output Termination

Termination for 2.5V LVPECL Outputs

Figure 14A and *Figure 14C* show examples of termination for 2.5V LVPECL driver. These terminations are equivalent to terminating 50Ω to V_{CCO} – 2V. For V_{CCO} = 2.5V, the V_{CCO} – 2V is very close to ground

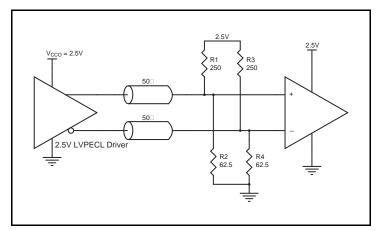


Figure 14A. 2.5V LVPECL Driver Termination Example

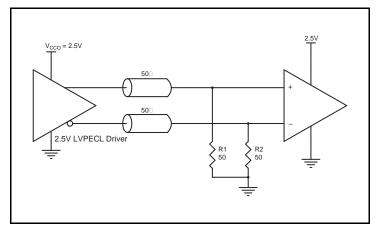


Figure 14B. 2.5V LVPECL Driver Termination Example

level. The R3 in *Figure 14C* can be eliminated and the termination is shown in *Figure 14B*.

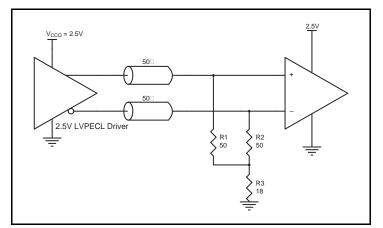


Figure 14C. 2.5V LVPECL Driver Termination Example

2.5V and 3.3V HCSL Output Termination

Figure 15A is the recommended source termination for applications where the driver and receiver will be on a separate PCBs. This termination is the standard for PCI Express[™] and HCSL output

types. All traces should be 50Ω impedance single-ended or 100Ω differential.

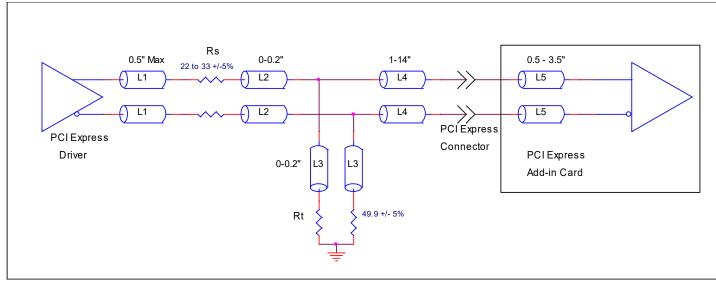


Figure 15A. Recommended Source Termination (where the driver and receiver will be on separate PCBs)

Figure 15B is the recommended termination for applications where a point-to-point connection can be used. A point-to-point connection contains both the driver and the receiver on the same PCB. With a matched termination at the receiver, transmission-line reflections will

be minimized. In addition, a series resistor (Rs) at the driver offers flexibility and can help dampen unwanted reflections. The optional resistor can range from 0Ω to 33Ω . All traces should be 50Ω impedance single-ended or 100Ω differential.

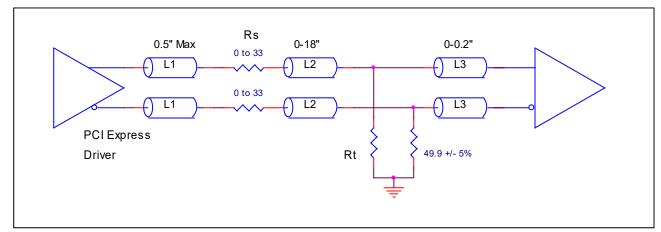


Figure 15B. Recommended Termination (where a point-to-point connection can be used)

VFQFN EPAD Thermal Release Path

In order to maximize both the removal of heat from the package and the electrical performance, a land pattern must be incorporated on the Printed Circuit Board (PCB) within the footprint of the package corresponding to the exposed metal pad or exposed heat slug on the package, as shown in *Figure 16*. The solderable area on the PCB, as defined by the solder mask, should be at least the same size/shape as the exposed pad/slug area on the package to maximize the thermal/electrical performance. Sufficient clearance should be designed on the PCB between the outer edges of the land pattern and the inner edges of pad pattern for the leads to avoid any shorts.

While the land pattern on the PCB provides a means of heat transfer and electrical grounding from the package to the board through a solder joint, thermal vias are necessary to effectively conduct from the surface of the PCB to the ground plane(s). The land pattern must be connected to ground through these vias. The vias act as "heat pipes". The number of vias (i.e. "heat pipes") are application specific and dependent upon the package power dissipation as well as electrical conductivity requirements. Thus, thermal and electrical analysis and/or testing are recommended to determine the minimum number needed. Maximum thermal and electrical performance is achieved when an array of vias is incorporated in the land pattern. It is recommended to use as many vias connected to ground as possible. It is also recommended that the via diameter should be 12 to 13mils (0.30 to 0.33mm) with 1oz copper via barrel plating. This is desirable to avoid any solder wicking inside the via during the soldering process which may result in voids in solder between the exposed pad/slug and the thermal land. Precautions should be taken to eliminate any solder voids between the exposed heat slug and the land pattern. Note: These recommendations are to be used as a guideline only. For further information, please refer to the Application Note on the Surface Mount Assembly of Amkor's Thermally/ Electrically Enhance Lead frame Base Package, Amkor Technology.

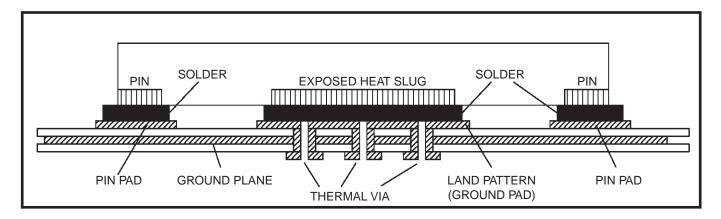


Figure 16. P.C. Assembly for Exposed Pad Thermal Release Path - Side View (drawing not to scale)

Schematic and Layout Information

Schematics for 8T49N286 can be found on IDT.com. Please search for the 8T49N286 device and click on the link for evaluation board schematics.

Crystal Recommendation

This device was validated using FOX 277LF series through-hole crystals including part #277LF-40-18 (40MHz) and 277LF-38.88-2 (38.88MHz). If a surface mount crystal is desired, we recommend FOX Part #603-40-48 (40MHz) or 603-38.88-7 (38.88MHz).

I²C Serial EEPROM Recommendation

The 8T49N286 was designed to operate with most standard I²C serial EEPROMs of 256 bytes or larger. Atmel AT24C04C was used during device characterization and is recommended for use. Please contact Renesas for review of any other I²C EEPROM's compatibility with the 8T49N286.

PCI Express Application Note

PCI Express jitter analysis methodology models the system response to reference clock jitter. The block diagram below shows the most frequently used *Common Clock Architecture* in which a copy of the reference clock is provided to both ends of the PCI Express Link.

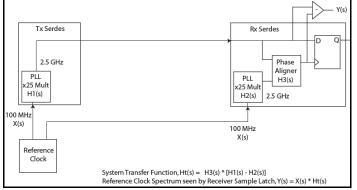
In the jitter analysis, the transmit (Tx) and receive (Rx) SerDes PLLs are modeled as well as the phase interpolator in the receiver. These transfer functions are called H1, H2, and H3 respectively. The overall system transfer function at the receiver is:

 $Ht(s) = H3(s) \times [H1(s) - H2(s)]$

The jitter spectrum seen by the receiver is the result of applying this system transfer function to the clock spectrum X(s) and is:

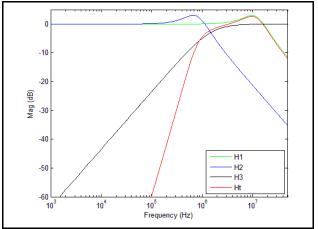
$$Y(s) = X(s) \times H3(s) \times [H1(s) - H2(s)]$$

In order to generate time domain jitter numbers, an inverse Fourier Transform is performed on X(s)*H3(s) * [H1(s) - H2(s)].



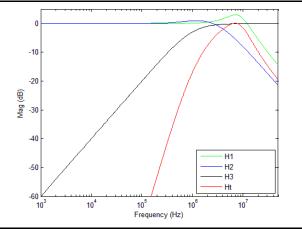


For **PCI Express Gen 1**, one transfer function is defined and the evaluation is performed over the entire spectrum: DC to Nyquist (e.g. for a 100MHz reference clock: OHz - 50MHz) and the jitter result is reported in peak-peak.

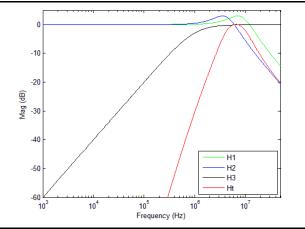


PCIe Gen 1 Magnitude of Transfer Function

For **PCI Express Gen 2**, two transfer functions are defined with 2 evaluation ranges and the final jitter number is reported in rms. The two evaluation ranges for PCI Express Gen 2 are 10kHz - 1.5MHz (Low Band) and 1.5MHz - Nyquist (High Band). The plots show the individual transfer functions as well as the overall transfer function Ht.

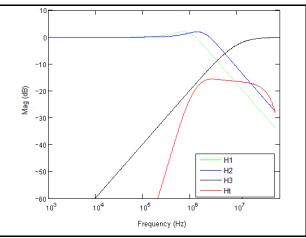


PCIe Gen 2A Magnitude of Transfer Function



PCIe Gen 2B Magnitude of Transfer Function

For **PCI Express Gen 3**, one transfer function is defined and the evaluation is performed over the entire spectrum. The transfer function parameters are different from Gen 1 and the jitter result is reported in RMS.



PCIe Gen 3 Magnitude of Transfer Function

For a more thorough overview of PCI Express jitter analysis methodology, please refer to Renesas Application Note, *PCI Express Application Note*.

Power Dissipation and Thermal Considerations

The 8T49N286 is a multi-functional, high speed device that targets a wide variety of clock frequencies and applications. Since this device is highly programmable with a broad range of features and functionality, the power consumption will vary as each of these features and functions is enabled.

The 8T49N286 device was designed and characterized to operate within the ambient industrial temperature range of -40°C to +85°C. The ambient temperature represents the temperature around the device, not the junction temperature. When using the device in extreme cases, such as maximum operating frequency and high ambient temperature, external air flow may be required in order to ensure a safe and reliable junction temperature. Extreme care must be taken to avoid exceeding 125°C junction temperature.

The power calculation examples below were generated using a maximum ambient temperature and supply voltage. For many applications, the power consumption will be much lower. Please contact Renesas technical support for any concerns on calculating the power dissipation for your own specific configuration.

Power Domains

The 8T49N286 device has a number of separate power domains that can be independently enabled and disabled via register accesses (all power supply pins must still be connected to a valid supply voltage). *Figure 17* below indicates the individual domains and the associated power pins.

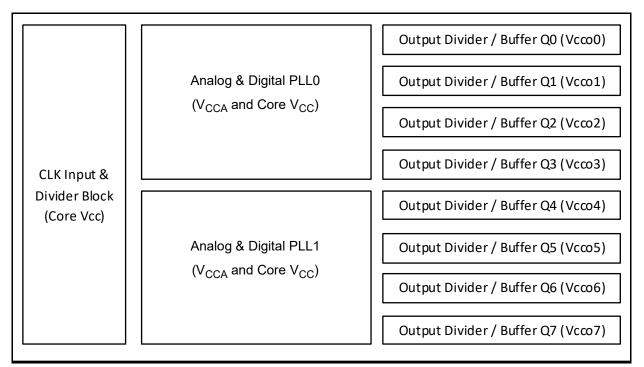


Figure 17. 8T49N286 Power Domains

For the output paths shown above, there are three different structures that are used. Q0 and Q1 use one output path structure, Q2 and Q3 use a second structure and Q[4:7] use a 3rd structure. Power consumption data will vary slightly depending on the structure used as shown in the appropriate tables below.

Power Consumption Calculation

Determining total power consumption involves several steps:

- 1. Determine the power consumption using maximum current values for core and analog voltage supplies from Table 8A and Table 8B.
- 2. Determine the nominal power consumption of each enabled output path.
 - a. This consists of a base amount of power that is independent of operating frequency, as shown in Table 17A through Table 17I (depending on the chosen output protocol).
 - b. Then there is a variable amount of power that is related to the output frequency. This can be determined by multiplying the output frequency by the FQ_Factor shown in Table 17A through Table 17I.
- 3. All of the above totals are then summed.

Thermal Considerations

Once the total power consumption has been determined, it is necessary to calculate the maximum operating junction temperature for the device under the environmental conditions it will operate in. Thermal conduction paths, air flow rate and ambient air temperature are factors that can affect this. The thermal conduction path refers to whether heat is to be conducted away via a heat-sink, via airflow or via conduction into the PCB through the device pads (including the ePAD). Thermal conduction data is provided for typical scenarios in Table 16 below. Please contact Renesas for assistance in calculating results under other scenarios.

Table 16. Thermal Resistance θ_{JA} for 72-Lead VFQFN, Forced Convection

θ _{JA} by Velocity				
Meters per Second	0	1	2	
Multi-Layer PCB, JEDEC Standard Test Boards	16.1°C/W	12.4°C/W	11.1°C/W	

Current Consumption Data and Equations

Table 17A. 3.3V LVPECL Output Calculation Table

Output	FQ_Factor (mA/MHz)	Base_Current (mA)	
Q0	0.00593	40.1	
Q1	0.00000	40.1	
Q2	0.01363	63.8	
Q3	0.01505	00.0	
Q4			
Q5	0.00591	42.9	
Q6	0.00091	42.3	
Q7			

Table 17B. 3.3V HCSL Output Calculation Table

Output	FQ_Factor (mA/MHz)	Base_Current (mA)	
Q0	0.00582	40.1	
Q1	0.00002	40.1	
Q2	0.01358	63.8	
Q3	0.01000	00.0	
Q4			
Q5	0.00553	43.1	
Q6	0.00555	45.1	
Q7			

Table 17C. 3.3V LVDS Output Calculation Table

Output	FQ_Factor (mA/MHz)	Base_Current (mA)		
Q0	0.00627	48.6		
Q1	0.00021	40.0		
Q2	0.01404	72.5		
Q3	0.01404	12.0		
Q4				
Q5	0.00630	51.3		
Q6	0.00030	51.5		
Q7				

Table 17D. 2.5V LVPECL Output Calculation Table

Output	FQ_Factor (mA/MHz)	Base_Current (mA)	
Q0	0.00373	32.8	
Q1	0.00070	02.0	
Q2	0.01134	56.5	
Q3	0.01134	50.5	
Q4			
Q5	0.00369	35.7	
Q6	0.00309	55.7	
Q7			

Table 17E. 2.5V HCSL Output Calculation Table

Output	FQ_Factor (mA/MHz)	Base_Current (mA)	
Q0	0.00354	32.9	
Q1	0.00004	52.5	
Q2	0.01125	56.5	
Q3	0.01125	50.5	
Q4			
Q5	0.00353	35.7	
Q6	0.00505	55.7	
Q7			

Table 17F. 2.5V LVDS Output Calculation Table

Output	FQ_Factor (mA/MHz)	Base_Current (mA)
Q0	0.00366	40.8
Q1	0.00000	40.0
Q2	0.01148	64.5
Q3	0.01110	01.0
Q4		
Q5	0.00367	43.7
Q6	0.00007	+0.7
Q7		

Table 17G. 3.3V LVCMOS Output Calculation Table

Output	Base_Current (mA)	
Q0	37.4	
Q1	57.4	
Q2	61.6	
Q3		
Q4		
Q5	40.6	
Q6		
Q7		

Table 17I. 1.8V LVCMOS Output Calculation Table

Output	Base_Current (mA)
Q0	27.4
Q1	27.4
Q2	51.4
Q3	51.4
Q4	
Q5	30.3
Q6	
Q7	

Table 17H. 2.5V LVCMOS Output Calculation Table

Output	Base_Current (mA)	
Q0	30.8	
Q1	50.0	
Q2	54.8	
Q3	- 54.0	
Q4		
Q5	33.7	
Q6	- 33.7	
Q7		

Applying the values to the following equation will yield output current by frequency:

Qx Current (mA) = FQ_Factor * Frequency (MHz) + Base_Current

where:

Qx Current is the specific output current according to output type and frequency

FQ_Factor is used for calculating current increase due to output frequency

Base_Current is the base current for each output path independent of output frequency

The second step is to multiply the power dissipated by the thermal impedance to determine the maximum power gradient, using the following equation:

 $T_{J} = T_{A} + (\theta_{JA} * Pd_{total})$

where:

 T_J is the junction temperature (°C)

 T_A is the ambient temperature (°C)

 θ_{JA} is the thermal resistance value from Table 16, dependent on ambient airflow (°C/W)

Pd_{total} is the total power dissipation of the 8T49N286 under usage conditions, including power dissipated due to loading (W).

Note that the power dissipation per output pair due to loading is assumed to be 27.95mW for LVPECL outputs and 44.5mW for HCSL outputs. When selecting LVCMOS outputs, power dissipation through the load will vary based on a variety of factors including termination type and trace length. For these examples, power dissipation through loading will be calculated using C_{PD} (found in Table 2) and output frequency:

 $Pd_{OUT} = C_{PD} * F_{OUT} * V_{CCO}^2$

where:

Pd_{OUT} is the power dissipation of the output (W)

C_{PD} is the power dissipation capacitance (pF)

 F_{OUT} is the output frequency of the selected output (MHz)

 V_{CCO} is the voltage supplied to the appropriate output (V)

Example Calculations

Example 1. Common Customer Configuration (3.3V Core Voltage)

Output	Output Type	Frequency (MHz)	V _{cco}
Q0	LVPECL	245.76	3.3
Q1	LVPECL	245.76	3.3
Q2	LVPECL	33.333	3.3
Q3	LVPECL	33.333	3.3
Q4	LVDS	125	3.3
Q5	LVDS	125	3.3
Q6	LVCMOS	25	3.3
Q7	LVCMOS	25	3.3
PLL0	Enabled		
PLL1	Enabled		

Core Supply Current, I_{CC} = 100mA (max)

Analog Supply Current, I_{CCA} = 275mA (max) Q0 Current = 0.00593x245.76 + 40.1 = 41.56mA Q1 Current = 0.00593x245.76 + 40.1 = 41.56mA Q2 Current = 0.01363x33.333 + 63.8 = 64.25mA Q3 Current = 0.01363x33.333 + 63.8 = 64.25mA Q4 Current = 0.00630x125 + 51.3 = 52.09mA Q5 Current = 0.00630x125 + 51.3 = 52.09mA Q6 Current = 40.6mA
Q7 Current = 40.6mA

- Total Output Current = 397mA (max)
 Total Device Current = 100mA + 275mA + 397mA = 772mA
 Total Device Power = 3.465V * 772mA = 2675mW
- · Power dissipated through output loading:

LVPECL = 27.95mW * 4 = **111.8mW**

LVDS = already accounted for in device power

HCSL = n/a

LVCMOS = 14.5pF * 25MHz * 3.465V² * 2 output pairs = **8.7mW**

• Total Power = 2675mW + 111.8mW + 8.7mW = 2795.5mW or 2.8W

With an ambient temperature of 85°C and no airflow, the junction temperature is:

T_J = 85°C + 16.1°C/W * 2.8W = **130.1°C**

This junction temperature is above the maximum allowable. In instances where maximum junction temperature is exceeded adjustments need to be made to either airflow or ambient temperature. In this case, adjusting airflow to 1m/s (θ_{JA} = 12.4°C/W) will reduce junction temperature to 119.7C. If no airflow adjustments can be made, the maximum ambient operating temperature must be reduced by a minimum of 5.1°C.

Example 2. High-Frequency Customer Configuration (3.3V Core Voltage)

Output	Output Type	Frequency (MHz)	V _{cco}
Q0	LVDS	625.00	2.5
Q1	LVDS	625.00	2.5
Q2	LVPECL	161.133	2.5
Q3	LVPECL	161.133	2.5
Q4	HCSL	25	3.3
Q5	HCSL	25	3.3
Q6	HCSL	125	3.3
Q7	HCSL 156.25		3.3
PLL0	Enabled		
PLL1	Disabled		

Core Supply Current, I_{CC} = 100mA (max)

Analog Supply Current, I_{CCA} = 187mA (max, PLL0 path only)

Q0 Current = 0.00366x625 + 40.8 = 43.09mA

Q1 Current = 0.00366x625 + 40.8 = 43.09mA

Q2 Current = 0.01134x161.133 + 56.5 = 58.3mA

Q3 Current = 0.01134x161.133 + 56.5 = 58.3mA

Q4 Current = 0.00553x25 + 43.1 = 43.24mA

Q5 Current = 0.00553x25 + 43.1 = 43.24mA

Q6 Current = 0.00553x125 + 43.1 = 43.79mA

Q7 Current = 0.00553x156.25 + 43.1 = 43.96mA

- Total Output Current = 202.8mA (V_{CCO} = 2.5V), 174.23mA (V_{CCO} = 3.3V)
 Total Device Power = 3.465V *(100mA + 187mA + 174.23mA) + 2.625V * 202.8mA = 2130.5mW
- Power dissipated through output loading:

LVPECL = 27.95mW * 2 = **55.9mW**

LVDS = already accounted for in device power

HCSL = 44.5mW * 4 = 178mW

LVCMOS = n/a

Total Power = 2130.5mW + 55.9mW + 178mW = 2364.4mW or 2.36W

With an ambient temperature of 85°C, the junction temperature is:

T_J = 85°C + 16.1°C/W *2.36W = **123°C**

This junction temperature is below the maximum allowable.

Example 3. Low Power Customer Configuration (2.5V Core Voltage)

Output	Output Type	Frequency (MHz)	V _{cco}
Q0	LVDS	156.25	2.5
Q1	LVDS	156.25	2.5
Q2	LVDS	161.133	2.5
Q3	LVCMOS	33.333	1.8
Q4	LVCMOS	25	1.8
Q5	LVCMOS	25	1.8
Q6	LVCMOS	25	1.8
Q7	LVDS	156.25	2.5
PLL0	Enabled		
PLL1	Enabled		

Core Supply Current, I_{CC} = 95mA (max)

Analog Supply Current, I_{CCA} = 270mA (max)

Q0 Current = 0.00366x156.25 + 40.8 = 41.37mA

Q1 Current = 0.00366x156.25 + 40.8 = 41.37mA

Q2 Current = 0.01148x161.133 + 64.5 = 66.35mA

Q3 Current = 51.4mA

Q4 Current = 30.3mA

Q5 Current = 30.3mA

Q6 Current = 30.3mA

Q7 Current = 0.00367x156.25 + 43.7 = 44.27mA

Total Output Current = 193.36mA (V_{CCO} = 2.5V), 142.3mA (V_{CCO} = 1.8V)
 Total Device Power = 2.625V *(95mA + 270mA + 193.36mA) + 1.89V * 142.3mA = 1734.6mW

• Power dissipated through output loading:

LVPECL = n/a

LVDS = already accounted for in device power

HCSL = n/a

LVCMOS_33.3MHz = 17pF * 33.3MHz * 1.89V² * 1 output pair = 2.02mW

LVCMOS 25MHz = 12.5pF * 25MHz * 1.89V² * 3 output pairs = 3.35mW

Total Power = 1734.6mW + 2.02mW + 3.35mW = **1740mW or 1.74W**

With an ambient temperature of 85°C, the junction temperature is:

T_J = 85°C + 16.1°C/W *1.74W = **113°C**

This junction temperature is below the maximum allowable.

Reliability Information

Table 18. θ_{JA} vs. Air Flow Table for a 72-Lead VFQFN

	θ_{JA} vs. Air Flow			
Meters per Second	0	1	2	
Multi-Layer PCB, JEDEC Standard Test Boards 16.1°C/W 12.4°C/W 11.1°C/W				

NOTE: Theta JA (θ_{JA})values calculated using a 4-layer JEDEC PCB (114.3mm x 101.6mm), with 2oz. (70um) copper plating on all 4 layers.

Transistor Count

The transistor count for 8T49N286 is: 998,958

Package Outline Drawings

The package outline drawings are appended at the end of this document and are accessible from the link below. The package information is the most current data available.

www.idt.com/document/psc/nlnlg72-package-outline-100-x-100-mm-body-epad-75-mm-sq-050-mm-pitch-qfn-sawn

Marking Diagram



- 1. Line 1 and Line 2 indicate the part number. "001" will vary due to configuration.
- 2. Line 3 indicates the following:
 - "#" denotes the stepping mark.
 - "YYWW" is the last two digits of the year and week that the part was assembled.
 - "\$" denotes the mark code.

Ordering Information

Table 19. Ordering Information

Part/Order Number	Marking	Package	Shipping Packaging	Temperature
8T49N286A-dddNLGI	IDT8T49N286A-dddNLGI	72-Lead VFQFN, Lead-Free	Tray	-40°C to +85°C
8T49N286A-dddNLGI8	IDT8T49N286A-dddNLGI	72-Lead VFQFN, Lead-Free	Tape & Reel, Pin 1 Orientation: EIA-481-C	-40°C to +85°C
8T49N286A-dddNLGI#	IDT8T49N286A-dddNLGI	72-Lead VFQFN, Lead-Free	Tape & Reel, Pin 1 Orientation: EIA-481-D	-40°C to +85°C

NOTE: For the specific, publicly available -ddd order codes, refer to *FemtoClock NG Universal Frequency Translator Ordering Product Information* document. For custom -ddd order codes, please contact Renesas for more information.

Table 20. Pin 1 Orientation in Tape and Reel Packaging

Part Number Suffix	Pin 1 Orientation	Illustration	
NLGI8	Quadrant 1 (EIA-481-C)	Correct Pin 1 ORIENTATION (Round Sprocket Holes) COCOCICIONOCOCICIONOCOCICION USER DIRECTION OF FEED	
NLGI#	Quadrant 2 (EIA-481-D)	Correct Pin 1 ORIENTATION CARRIER TAPE TOPSIDE (Round Sprocket Holes)	

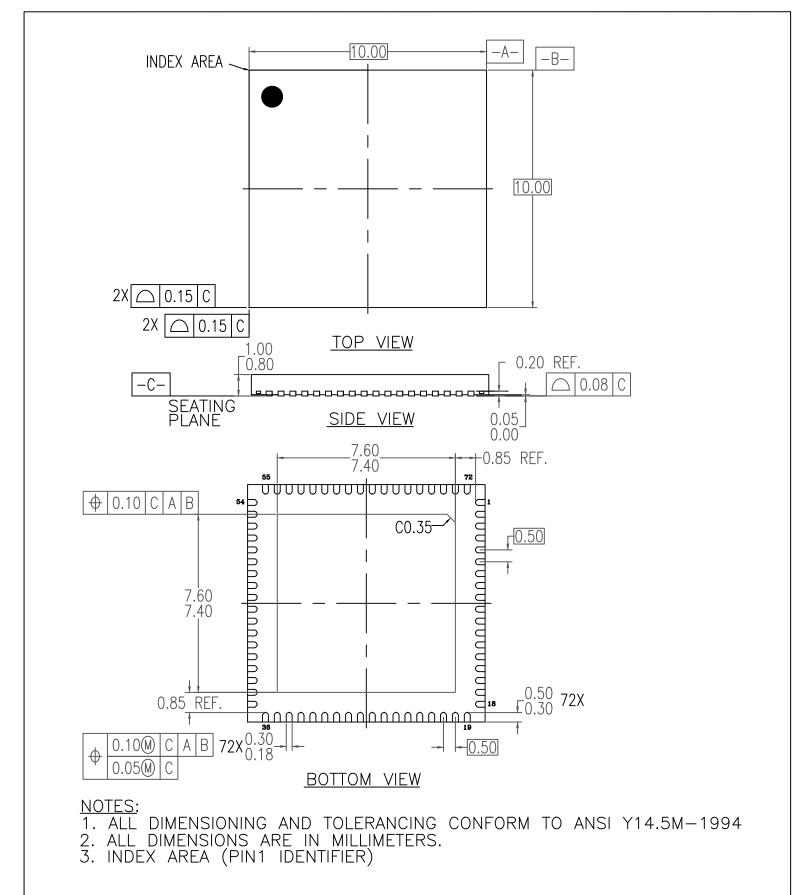
Revision History

Revision Date	Description of Change		
October 28, 2020	Updated Figure 8A		
July 15, 2020	Corrected the Marking Diagram descriptionChanged IDT references to Renesas		
January 18, 2019	 Corrected the I²C read sequence diagrams in Figure 6 and Figure 7 to match I²C specification and device actual performance. Note: Only the drawings were incorrect – the part's behavior did not change and continues to meet the I²C specification. Added a Marking Diagram 		
February 2, 2018	Updated I2C Mode Operation to indicate support for v2.1 of the I2C specification		
	Added a note before Digital PLL0 Status Register Bit Field Locations and Descriptions and Digital PLL1 Status Register Bit Field Locations and Descriptions		
September 8, 2017	Added the following fields to Digital PLL0 Status Register Bit Field Locations and Descriptions and Digital PLL1		
	Status Register Bit Field Locations and Descriptions: NO_REF, SM_STS, and PLLLCK		
	Updated the package outline drawings; however, no mechanical changes		
October 27, 2016	Crystal Recommendation - deleted IDT crystal reference.		
February 1, 2016	T19, Per PCN# W1512-01, Effective Date 03/18/2016 - changed Part/Order Number from 8T49N286-dddNLGI to 8T49N286A-dddNLGI, and Marking from IDT8T49N286-dddNLGI to IDT8T49N286A-dddNLGI.		
	Updated Datasheet header/footer.		
July 8, 2015	Device Start-up and Reset Behavior - added second paragraph.		
May 6, 2015	Digital PLL0 Feedback Control Register Bit Field Table - deleted ACQBW0[3:0]'s "0000 = 512mHz" AC Characteristics Table - added missing minimum Output Frequency spec for Q2, Q3 (LVPECL, LVDS) and LVCMOS. "Termination for 3.3V LVPECL Outputs" - updated Figure 13A. "Crystal Recommendation" - included additional crystal recommendation. Deleted IDT prefix/suffix throughout the datasheet.		
	Table 12, AC Characteristics Table - updated LVDS Rise/Fall Time maximum spec. from 500 to 400ps.		
February 17, 2015	Miscellaneous content enhancement in: Output Phase Control on Switchover section; Table 7A, Table 7C, Table 7E and Table 7G, Table 7S, and Pin Assignment format.		
December 8, 2014	Block Diagram - corrected divide symbol.		



72-VFQFPN, Package Outline Drawing

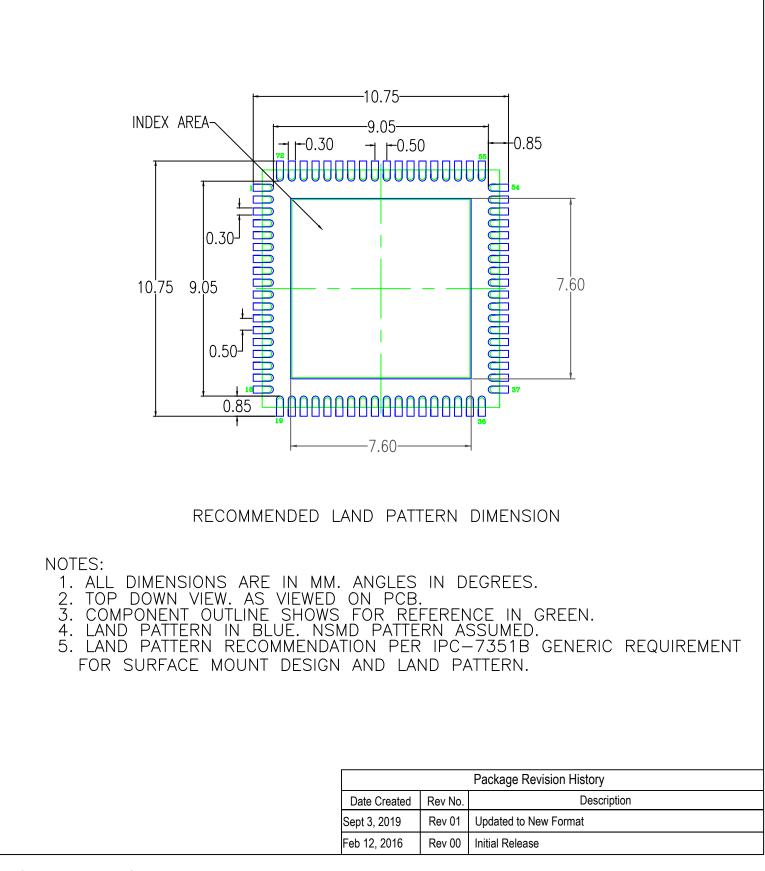
10.0 x 10.0 x 0.90 mm Body, Epad 7.50 x 7.50 mm 0.50mm Pitch NLG72P2, PSC-4208-02, Rev 01, Page 1





72-VFQFPN, Package Outline Drawing

10.0 x 10.0 x 0.90 mm Body, Epad 7.50 x 7.50 mm 0.50mm Pitch NLG72P2, PSC-4208-02, Rev 01, Page 2



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(Rev.1.0 Mar 2020)

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